

FCC REPORT

(LTE)

Applicant: IrisGuard UK Ltd.

Address of Applicant: 43 Shenley Pavilions, Chalkdell Drive, Shenley Wood, Milton Keynes MK5 6LB, Buckinghamshire, UK

Equipment Under Test (EUT)

Product Name: Smartphone

Model No.: IG-EP100, EyePay Phone

Trade mark: EyePay

FCC ID: 2AUG7IG-EP100

Applicable standards: FCC CFR Title 47 Part 2
FCC CFR Title 47 Part 22 Subpart H

Date of sample receipt: 24 Jul., 2019

Date of Test: 24 Jul., to 22 Aug., 2019

Date of report issued: 23 Aug., 2019

Test Result: PASS*

*In the configuration tested, the EUT complied with the standards specified above.

Authorized Signature:



Bruce Zhang
Laboratory Manager

This report details the results of the testing carried out on one sample. The results contained in this test report do not relate to other samples of the same product and does not permit the use of the CCIS product certification mark. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report.

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2. Version

Version No.	Date	Description
00	23 Aug., 2019	Original
01	03 Sep.,2019	Updated FCC ID

Tested by:

Carey Chen

Date:

23 Aug., 2019

Test Engineer

Reviewed by:

Winner Zhang

Date:

23 Aug., 2019

Project Engineer

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4. Test Summary

Test Items	Section in CFR 47	Result
RF Exposure (SAR)	Part 1.1307 Part 2.1093	Passed (Please refer to SAR Report)
RF Output Power	Part 2.1046 Part 22.913 (a)(2)	Pass
Peak-to-Average Ratio	N/A	Pass
Modulation Characteristics	Part 2.1047	Pass
99% & -26 dB Occupied Bandwidth	Part 2.1049 Part 22.917(b)	Pass
Out of band emission at antenna terminals	Part 2.1053 Part 22.917(a)	Pass
Field strength of spurious radiation	Part 22.917(a)	Pass
Frequency stability vs. temperature	Part 22.355 Part 2.1055(a)(1)(b)	Pass
Frequency stability vs. voltage	Part 22.355 Part 2.1055(d)(2)	Pass
<i>Pass: The EUT complies with the essential requirements in the standard.</i>		

5. General Information

5.1 Client Information

Applicant:	IrisGuard UK Ltd.
Address:	43 Shenley Pavilions, Chalkdell Drive, Shenley Wood, Milton Keynes MK5 6LB, Buckinghamshire, UK
Manufacturer:	Huizhou Lingyun Technology Co., Ltd.
Address:	No.13 Jinda Road, Huinan Hi-tech Industrial Park, Huiao Avenue, Huizhou, China

5.2 General Description of E.U.T.

Product Name:	Smartphone
Model No.:	IG-EP100, EyePay Phone
Operation Frequency range:	LTE Band 5: 824MHz-849MHz, RX: 869MHz-894MHz
Modulation type:	QPSK, 16QAM
Antenna type:	Internal Antenna
Antenna gain:	LTE Band 5: -0.35dBi
Power supply:	Rechargeable Li-ion Battery DC3.85V-3850mAh
AC adapter:	Model: DCS10-0501000F Input: AC100-240V, 50/60Hz, 0.3A Output: DC 5.0V, 1000mA
Test Sample Condition:	The applicant provided engineering samples for staying in continuously transmitting for testing.
Remark	Model No.: IG-EP100, EyePay Phone were identical inside, the electrical circuit design, layout, components used and internal wiring, with only difference being model name and color.

Operation Frequency List:

LTE Band 5 (1.4MHz)		LTE Band 5 (3MHz)	
Channel	Frequency (MHz)	Channel	Frequency (MHz)
20407	824.70	20415	825.50
20408	824.80	20416	825.60
....			
20524	836.40	20524	836.40
20525	836.50	20525	836.50
20526	836.60	20526	836.60
...	...	...	...
20642	848.20	20634	847.40
20643	848.30	20635	847.50
LTE Band 5 (5MHz)		LTE Band 5 (10MHz)	
Channel	Frequency (MHz)	Channel	Frequency (MHz)
20425	826.50	20450	829.00
20426	826.60	20451	829.10
....			
20524	836.40	20524	836.40
20525	836.50	20525	836.50
20526	836.60	20526	836.60
...	...	...	...
20624	846.40	20599	839.90
20625	846.50	20600	844.00

Regards to the operating frequency range, the lowest frequency, the middle frequency, and the highest frequency of channel were selected to perform the test, and the selected channels as below:

LTE Band 5 (1.4MHz)			LTE Band 5 (3MHz)		
Channel:		Frequency (MHz)	Channel		Frequency (MHz)
Lowest channel	20407	824.70	Lowest channel	20415	825.50
Middle channel	20525	836.50	Middle channel	20525	836.50
Highest channel	20643	848.30	Highest channel	20635	847.50
LTE Band 5 (5MHz)			LTE Band 5 (10MHz)		
Channel		Frequency (MHz)	Channel		Frequency (MHz)
Lowest channel	20425	826.50	Lowest channel	20450	829.00
Middle channel	20525	836.50	Middle channel	20525	836.50
Highest channel	20625	846.50	Highest channel	20600	844.00

5.3 Test environment and mode

Operating Environment:	
Temperature:	Normal: 15°C ~ 35°C, Extreme: -30°C ~ +50°C
Humidity:	20 % ~ 75 % RH
Atmospheric Pressure:	1008 mbar
Voltage:	Nominal: 3.85Vdc, Extreme: Low 3.5Vdc, High 4.4Vdc
Test mode:	
LTE QPSK mode	Keep the EUT communication with simulated station in QPSK mode
LTE 16-QAM mode	Keep the EUT communication with simulated station in 16-QAM mode
Remark: The EUT has been tested under continuous transmitting mode. Channel Low, Mid and High for each type band with rated data rate were chosen for full testing. The field strength of spurious radiation emission was measured as EUT stand-up position (H mode) and lie down position (E1, E2 mode) for these modes with power adaptor, earphone and Data cable. Just the worst case position (H mode) shown in report.	

5.4 Description of Support Units

Test Equipment	Manufacturer	Model No.	Serial No.
Simulated Station	Anritsu	MT8820C	6201026545

5.5 Measurement Uncertainty

Parameters	Expanded Uncertainty
Radiated Emission (9kHz ~ 30MHz)	±3.12 dB (k=2)
Radiated Emission (30MHz ~ 1000MHz)	±4.32 dB (k=2)
Radiated Emission (1GHz ~ 18GHz)	±5.38 dB (k=2)
Radiated Emission (18GHz ~ 40GHz)	±3.36 dB (k=2)

5.6 Related Submittal(s) / Grant (s)

This is an original grant, no related submittals and grants.

5.7 Laboratory Facility

The test facility is recognized, certified, or accredited by the following organizations:

- **FCC - Designation No.: CN1211**

Shenzhen Zhongjian Nanfang Testing Co., Ltd. has been accredited as a testing laboratory by FCC (Federal Communications Commission). The test firm Registration No. is 727551.

- **ISED – CAB identifier.: CN0021**

The 3m Semi-anechoic chamber of Shenzhen Zhongjian Nanfang Testing Co., Ltd. has been Registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 10106A-1.

- **CNAS - Registration No.: CNAS L6048**

Shenzhen Zhongjian Nanfang Testing Co., Ltd. is accredited to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration laboratories for the competence of testing. The Registration No. is CNAS L6048.

- **A2LA - Registration No.: 4346.01**

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 General requirements for the competence of testing and calibration laboratories. The test scope can be found as below link: <https://portal.a2la.org/scopepdf/4346-01.pdf>

5.8 Laboratory Location

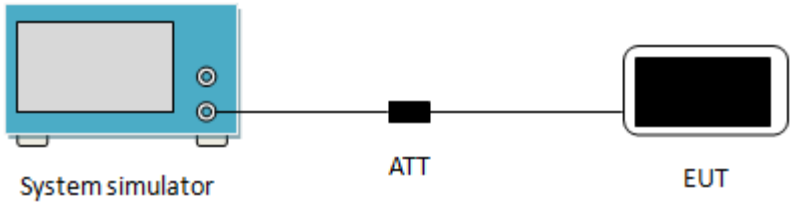
Shenzhen Zhongjian Nanfang Testing Co., Ltd.
Address: No. B-C, 1/F., Building 2, Laodong No.2 Industrial Park, Xixiang Road,
Bao'an District, Shenzhen, Guangdong, China
Tel: +86-755-23118282, Fax: +86-755-23116366
Email: info@ccis-cb.com, Website: <http://www.ccis-cb.com>

5.9 Test Instruments list

Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date (mm-dd-yy)	Cal. Due date (mm-dd-yy)
3m SAC	SAEMC	9m*6m*6m	966	07-22-2017	07-21-2020
BiConiLog Antenna	SCHWARZBECK	VULB9163	497	03-18-2019	03-17-2020
Biconical Antenna	SCHWARZBECK	VUBA9117	359	06-22-2017	06-21-2020
Horn Antenna	SCHWARZBECK	BBHA9120D	916	03-18-2019	03-17-2020
Horn Antenna	SCHWARZBECK	BBHA9120D	1805	06-22-2017	06-21-2020
Horn Antenna	SCHWARZBECK	BBHA 9170	BBHA9170582	11-21-2018	11-20-2019
EMI Test Software	AUDIX	E3	Version: 6.110919b		
Pre-amplifier	HP	8447D	2944A09358	03-18-2019	03-17-2020
Pre-amplifier	CD	PAP-1G18	11804	03-18-2019	03-17-2020
Spectrum analyzer	Rohde & Schwarz	FSP30	101454	03-18-2019	03-17-2020
EMI Test Receiver	Rohde & Schwarz	ESRP7	101070	03-18-2019	03-17-2020
Spectrum Analyzer	Agilent	N9020A	MY50510123	10-29-2018	10-28-2019
Signal Generator	Rohde & Schwarz	SMX	835454/016	03-18-2019	03-17-2020
Signal Generator	R&S	SMR20	1008100050	03-18-2019	03-17-2020
RF Switch Unit	MWRFTTEST	MW200	N/A	N/A	N/A
Test Software	MWRFTTEST	MTS8200	Version: 2.0.0.0		
Cable	ZDECL	Z108-NJ-NJ-81	1608458	03-18-2019	03-17-2020
Cable	MICRO-COAX	MFR64639	K10742-5	03-18-2019	03-17-2020
Cable	SUHNER	SUCOFLEX100	58193/4PE	03-18-2019	03-17-2020
DC Power Supply	XinNuoEr	WYK-10020K	1409050110020	10-31-2018	10-30-2019
Temperature Humidity Chamber	HengPu	HPGDS-500	20140828008	09-24-2018	09-23-2019
Simulated Station	Rohde & Schwarz	CMW500	140493	07-16-2018	07-15-2019
				07-16-2019	07-15-2020

6. Test results

6.1 Conducted Output Power, ERP and EIRP

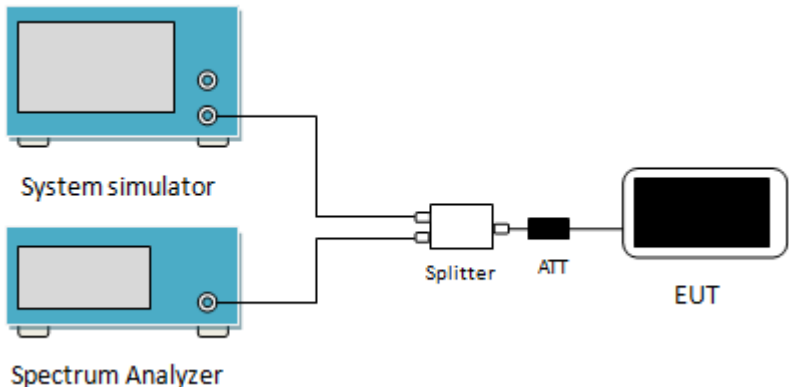
Test Requirement:	Part 22.913(a)(2)
Test Method:	ANSI/TIA-603-D 2010
Limit:	Band 5: 7W, LTE
Test Setup:	 The diagram illustrates the test setup. On the left is a blue rectangular box labeled 'System simulator'. A line connects its right side to a small black square labeled 'ATT' (attenuator). Another line connects the right side of the 'ATT' to a black rectangular box labeled 'EUT' (Equipment Under Test).
Test Procedure:	The transmitter output was connected to a calibrated attenuator, the other end of which was connected to the CMW500. Transmitter output power was read off in dBm.
Test Instruments:	Refer to section 5.9 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed

Measurement Data:

LTE Band	Bandwidth (MHz)	Modulation	RB Size	RB Offset	Average Power (dBm)			
					20407	20525	20643	
					824.7MHz	836.5MHz	848.3MHz	
5	1.4	QPSK	1	0	23.10	23.21	23.21	
			1	2	23.21	22.89	23.09	
			1	5	23.16	22.74	22.91	
			3	0	21.96	21.76	21.88	
			3	1	22.05	21.88	21.92	
			3	2	22.00	21.80	21.91	
			6	0	22.49	22.04	21.98	
		Antenna Gain(dBi):				-0.35		
		Max. ERP (dBm):				20.71		
		ERP Limit (dBm):				38.45		
		16QAM	1	0	22.80	22.30	22.21	
			1	2	22.91	21.91	22.33	
			1	5	22.94	21.95	21.90	
			3	0	22.29	22.09	22.16	
			3	1	22.55	22.07	22.19	
			3	2	22.09	22.05	21.88	
			6	0	21.86	20.94	21.00	
		Antenna Gain(dBi):				-0.35		
		Max. ERP (dBm):				20.44		
		ERP Limit (dBm):				38.45		
LTE Band	Bandwidth (MHz)	Modulation	RB Size	RB Offset	Average Power (dBm)			
					20415	20525	20635	
					825.5MHz	836.5MHz	847.50MHz	
5	3	QPSK	1	0	22.98	22.94	22.93	
			1	7	22.93	22.82	22.88	
			1	14	22.80	22.91	22.76	
			8	0	21.91	21.88	21.98	
			8	4	21.92	22.00	22.02	
			8	7	21.88	21.80	21.94	
			15	0	21.98	21.92	21.92	
		Antenna Gain(dBi):				-0.35		
		Max. ERP (dBm):				20.48		
		ERP Limit (dBm):				38.45		
		16QAM	1	0	22.31	21.95	22.30	
			1	7	22.00	22.03	22.09	
			1	14	21.80	21.99	21.91	
			8	0	20.91	20.80	21.20	
			8	4	20.82	21.04	20.98	
			8	7	20.98	20.86	21.09	
			15	0	20.92	20.80	20.91	
		Antenna Gain(dBi):				-0.35		
		Max. ERP (dBm):				19.81		
		ERP Limit (dBm):				38.45		
Note: EIRP (dBm) = Average power (dBm) + Antenna Gain (dBi). ERP (dBm) = EIRP (dBm) - 2.15 (dB).								

LTE Band	Bandwidth (MHz)	Modulation	RB Size	RB Offset	Average Power (dBm)			
					20425	20525	20625	
					826.5MHz	836.5MHz	846.5MHz	
5	5	QPSK	1	0	22.93	22.91	22.83	
			1	12	22.98	22.76	22.88	
			1	24	22.82	22.98	22.76	
			12	0	21.89	21.82	21.91	
			12	6	21.80	21.92	21.76	
			12	11	21.94	21.98	21.98	
			25	0	21.85	21.93	21.82	
		Antenna Gain(dBi):				-0.35		
		Max. ERP (dBm):				20.48		
		ERP Limit (dBm):				38.45		
		16QAM	1	0	21.93	21.82	21.88	
			1	12	22.06	21.88	21.76	
			1	24	21.88	21.91	21.98	
			12	0	21.00	21.04	20.82	
			12	6	20.94	20.92	20.93	
			12	11	21.09	20.79	21.04	
			25	0	20.91	20.87	20.98	
		Antenna Gain(dBi):				-0.35		
		Max. ERP (dBm):				19.56		
		ERP Limit (dBm):				38.45		
LTE Band	Bandwidth (MHz)	Modulation	RB Size	RB Offset	Average Power (dBm)			
					20450	20525	20600	
					829.0MHz	836.5MHz	844.0MHz	
5	10	QPSK	1	0	23.03	23.13	22.86	
			1	24	23.12	22.9	23.01	
			1	49	22.96	22.91	23.02	
			25	0	22.09	21.98	21.99	
			25	12	22.04	21.89	21.98	
			25	24	21.88	21.88	21.79	
			50	0	21.97	21.92	21.92	
		Antenna Gain(dBi):				-0.35		
		Max. ERP (dBm):				20.63		
		ERP Limit (dBm):				38.45		
		16QAM	1	0	21.88	22.20	21.89	
			1	24	21.82	22.04	21.88	
			1	49	21.98	21.77	22.19	
			25	0	20.98	20.83	20.80	
			25	12	21.15	20.93	20.94	
			25	24	20.82	20.76	20.82	
			50	0	20.98	21.02	20.94	
		Antenna Gain(dBi):				-0.35		
		Max. ERP (dBm):				19.70		
		ERP Limit (dBm):				38.45		
Note: EIRP (dBm) = Average power (dBm) + Antenna Gain (dBi). ERP (dBm) = EIRP (dBm) - 2.15 (dB).								

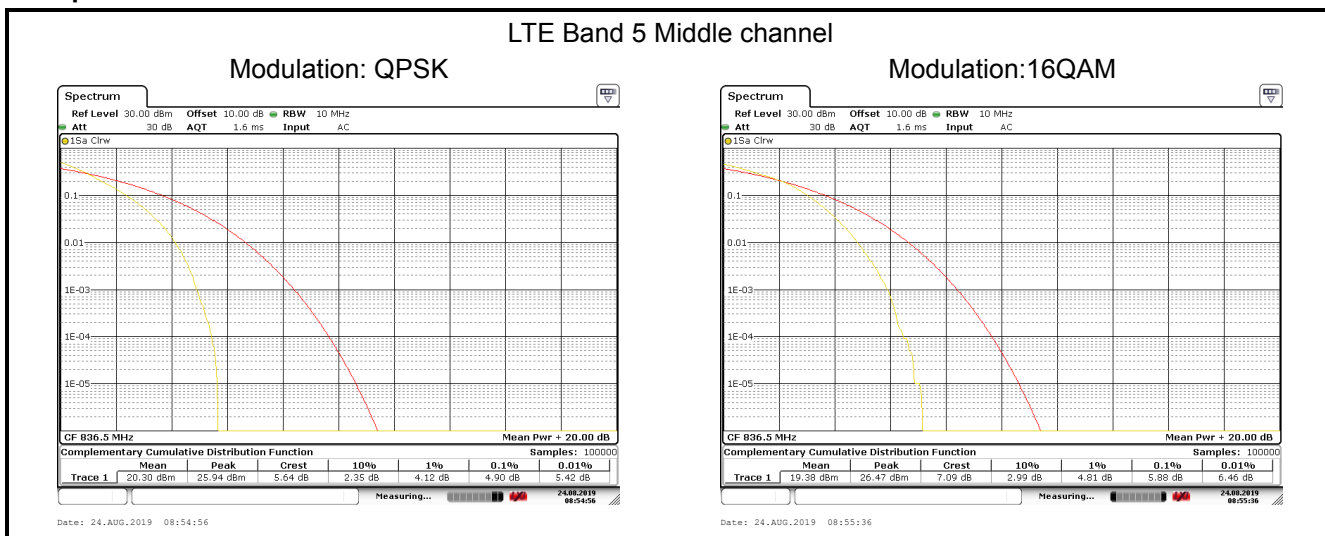
6.2 Peak-to-Average Ratio

Test Requirement:	N/A
Test Method:	ANSI C63.26-2015
Limit:	The peak-to-average ratio (PAR) of the transmission may not exceed 13 dB.
Test Setup:	 The diagram illustrates the test setup. On the left, there are two blue rectangular units: the top one is labeled 'System simulator' and the bottom one is labeled 'Spectrum Analyzer'. Both have a single output port. These two ports are connected to a central 'Splitter' unit. From the 'Splitter', one line goes to an 'ATT' (Attenuator) unit, and another line goes to the 'EUT' (Equipment Under Test), which is represented by a black rectangular unit with a screen.
Test Procedure:	1 The RF output of the transceiver was connected to a spectrum analyzer through appropriate attenuation. 2 Set the CCDF option in spectrum analyzer, $RBW \geq OBW$, 3 Set the EUT working in highest power level, measured and recorded the 0.1% as PAPR level. 4 Repeat step 1~3 at other frequency and modulations.
Test Instruments:	Refer to section 5.9 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed

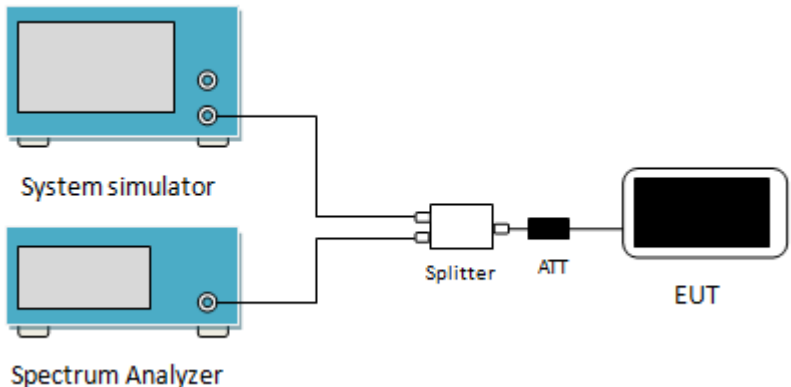
Measurement Data (Worst case):

Bandwidth	Modulation	RB Size	RB Offset	PAPR
LTE Band 5 (Middle Channel)				
10MHz	QPSK	50	0	4.90
	16QAM	50	0	5.88

Test plots as below:



6.3 Occupy Bandwidth

Test Requirement:	Part 22.917(b)
Test Method:	ANSI/TIA-603-D 2010
Test Setup:	 The diagram illustrates the test setup. On the left, there are two blue rectangular units: the top one is labeled 'System simulator' and the bottom one is labeled 'Spectrum Analyzer'. Both have a single output port. These two ports are connected to a central 'Splitter' unit. From the 'Splitter', one line goes to an 'ATT' (Attenuator) unit, and another line goes to the 'EUT' (Equipment Under Test), which is represented by a black rectangular unit with a screen.
Test Procedure:	1. The EUT's output RF connector was connected with a short cable to the spectrum analyzer 2. RBW was set to about 1% ~ 5% of emission BW, VBW= 3 times RBW. 3. -26dBc display line was placed on the screen (or 99% bandwidth), the occupied bandwidth is the delta frequency between the two points where the display line intersects the signal trace.
Test Instruments:	Refer to section 5.9 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed

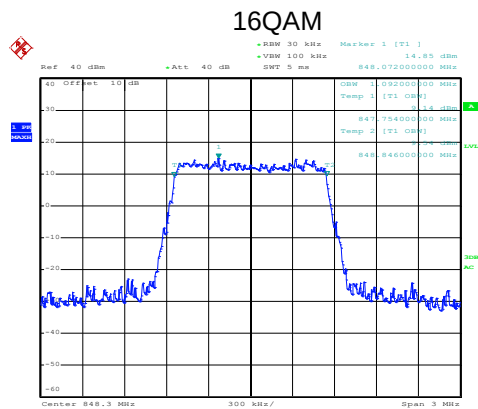
Measurement Data:

TE Band 5					
Bandwidth	Channel	Frequency (MHz)	Modulation	99% OBW (kHz)	-26dBcEBW (kHz)
1.4MHz	20407	824.7	16QAM	1092	1266
			QPSK	1098	1254
	20525	836.5	16QAM	1098	1260
			QPSK	1098	1254
	20643	848.3	16QAM	1092	1266
			QPSK	1104	1266
3MHz	20415	825.5	16QAM	2724	3000
			QPSK	2748	3024
	20525	836.50	16QAM	2724	2976
			QPSK	2736	3036
	20635	847.50	16QAM	2724	3024
			QPSK	2736	3048
5MHz	20425	826.50	16QAM	4480	4920
			QPSK	4520	5000
	20525	836.50	16QAM	4520	4880
			QPSK	4520	5060
	20625	846.50	16QAM	4520	4980
			QPSK	4540	5080
10MHz	20450	829.00	16QAM	9120	10080
			QPSK	9080	10280
	20525	836.50	16QAM	9160	10080
			QPSK	9160	10280
	20600	844.00	16QAM	9120	10080
			QPSK	9120	10200

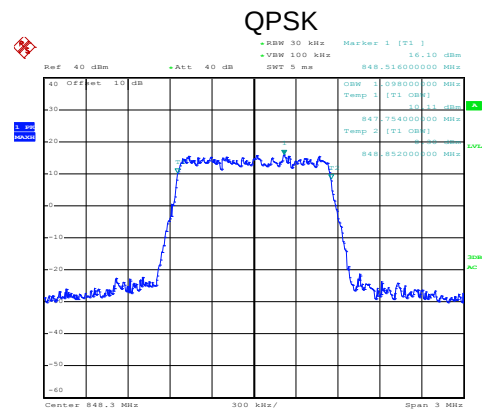
Test plot as follows:

LTE Band 5 part:

LTE Band 5: 99% Occupy bandwidth
BW: 1.4MHz

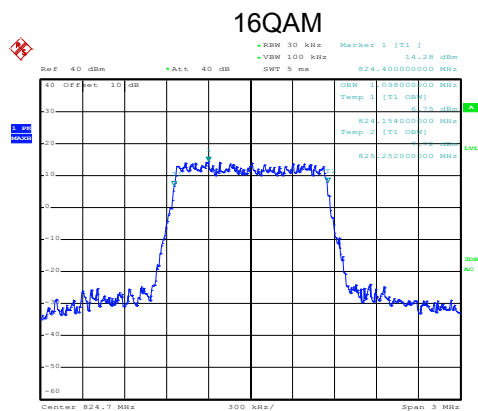


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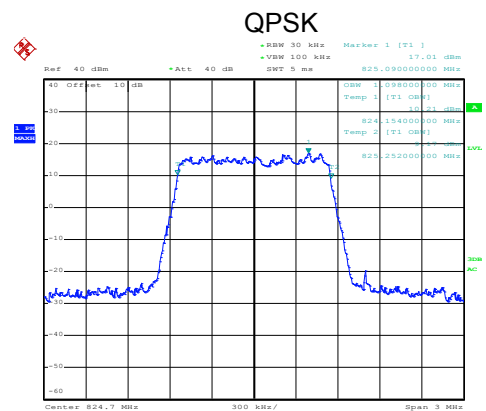


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Lowest channel

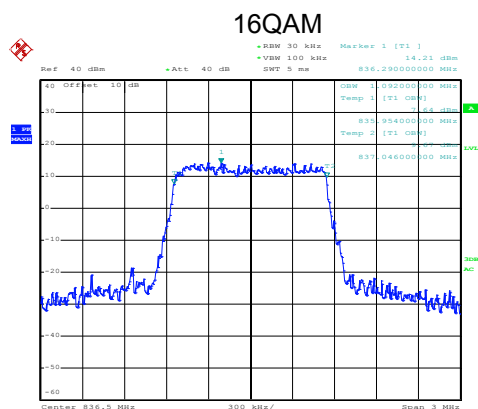


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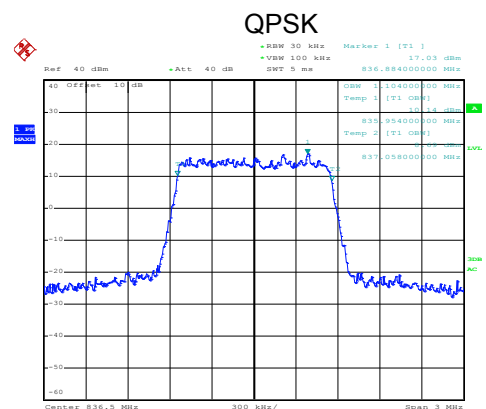


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Middle channel



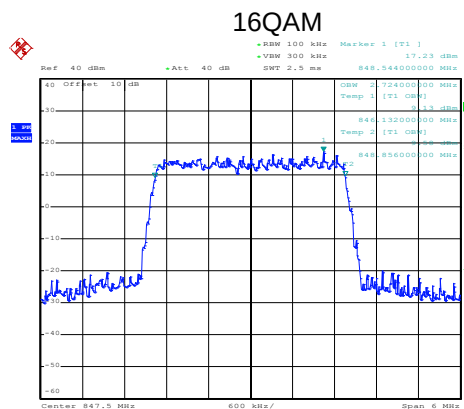
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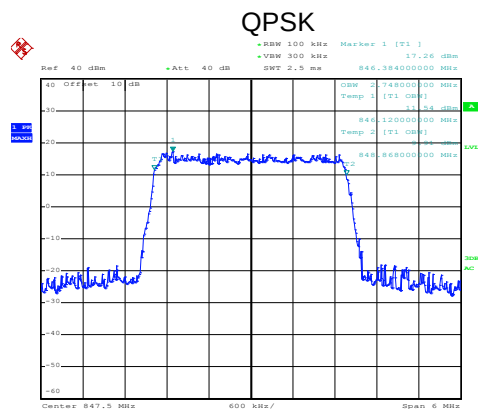
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Highest channel

LTE Band 5: 99% Occupancy bandwidth BW: 3MHz

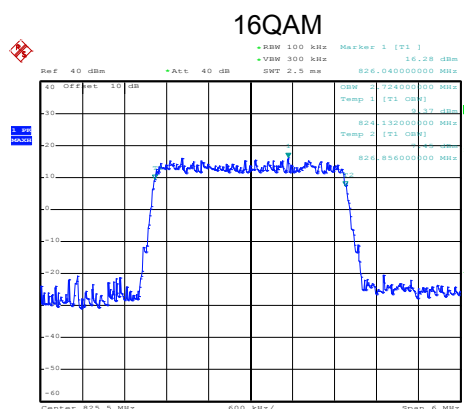


Date: 20.AUG.2019 15:00:18

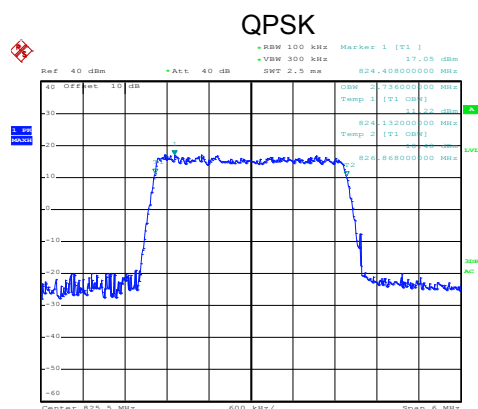


Date: 20.AUG.2019 15:00:14

Lowest channel

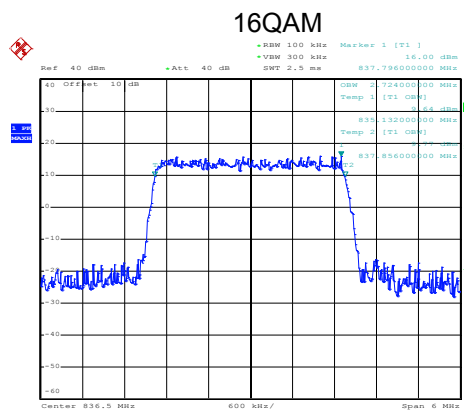


Date: 20.AUG.2019 14:59:23

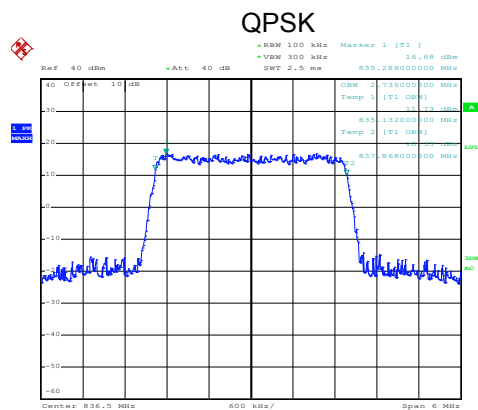


Date: 20.AUG.2019 14:59:18

Middle channel



Date: 20.AUG.2019 15:00:03

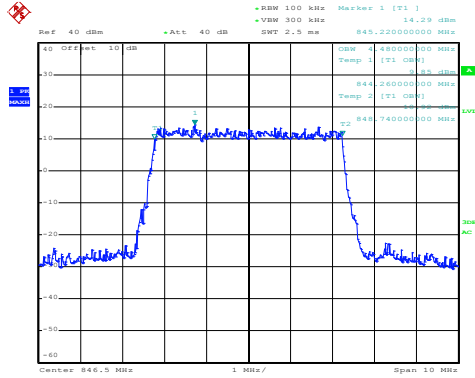


Date: 20.AUG.2019 14:59:58

Highest channel

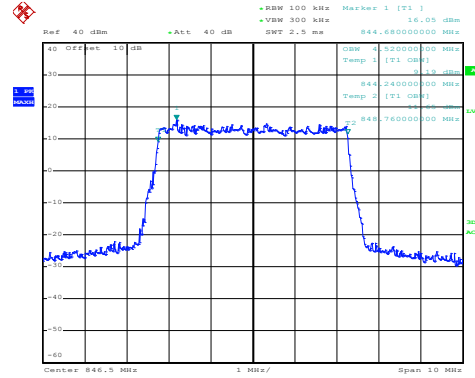
LTE Band 5: 99% Occupancy bandwidth BW: 5MHz

16QAM



Date: 20.AUG.2019 15:02:34

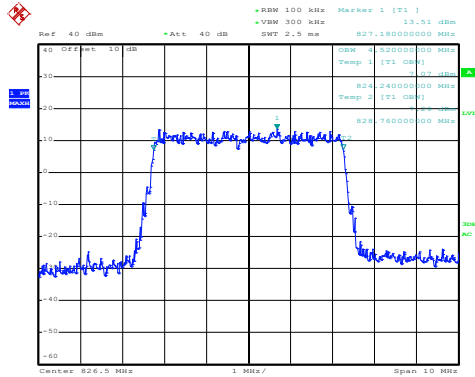
QPSK



Date: 20.AUG.2019 15:02:29

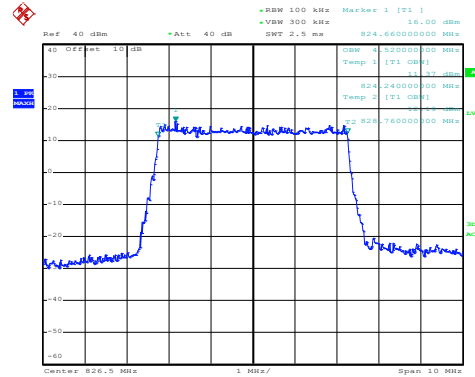
Lowest channel

16QAM



Date: 20.AUG.2019 15:01:17

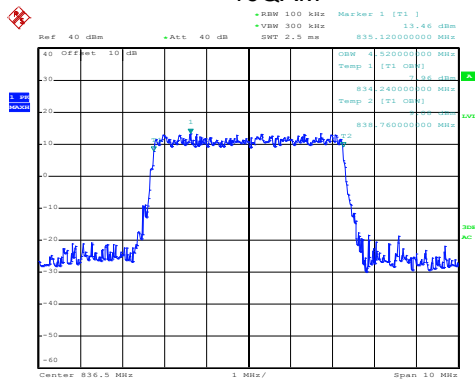
QPSK



Date: 20.AUG.2019 15:01:12

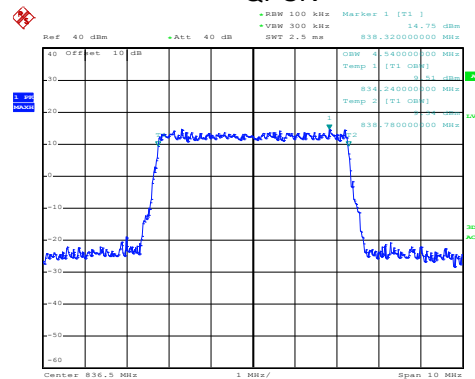
Middle channel

16QAM



Date: 20.AUG.2019 15:01:33

QPSK

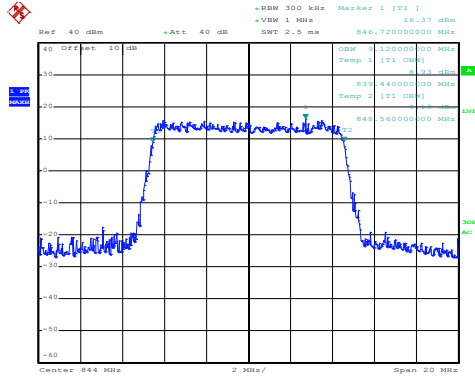


Date: 20.AUG.2019 15:01:29

Highest channel

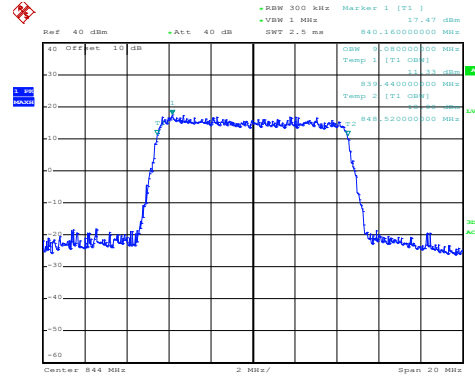
LTE Band 5: 99% Occupancy bandwidth BW: 10MHz

16QAM



Date: 20.AUG.2019 15:04:07

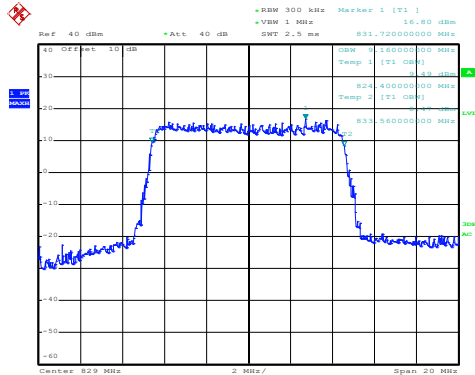
QPSK



Date: 20.AUG.2019 15:04:02

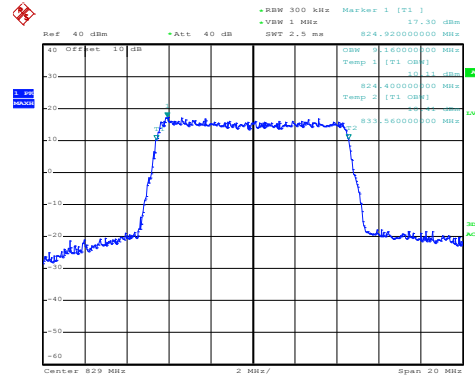
Lowest channel

16QAM



Date: 20.AUG.2019 15:03:03

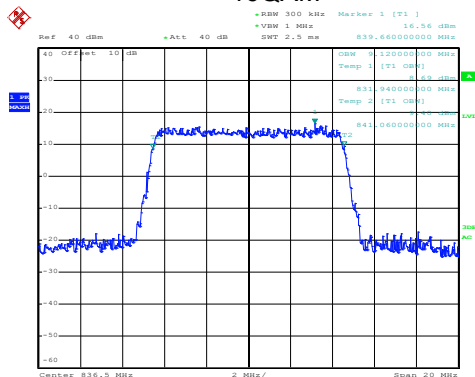
QPSK



Date: 20.AUG.2019 15:02:58

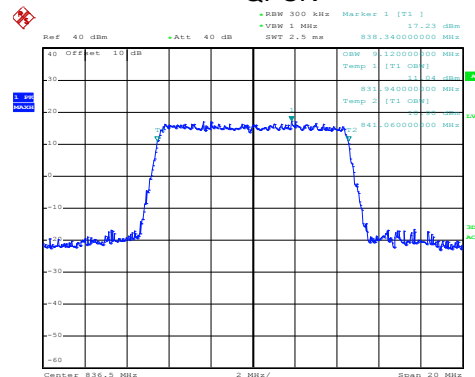
Middle channel

16QAM



Date: 20.AUG.2019 15:03:49

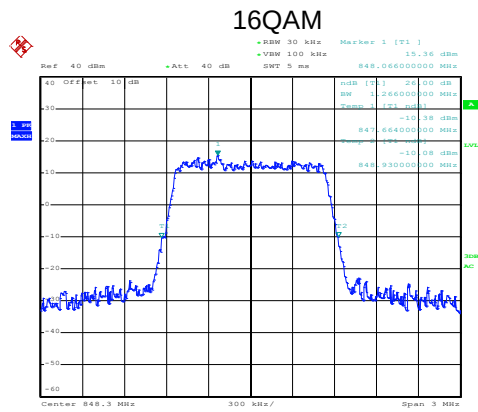
QPSK



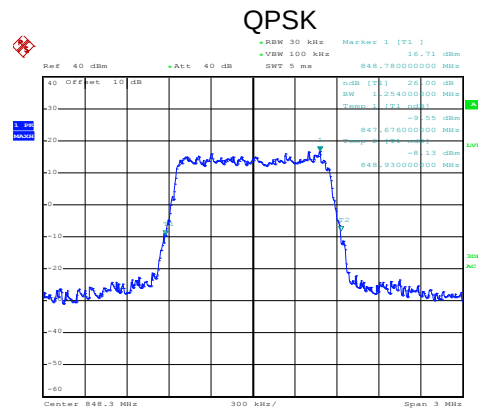
Date: 20.AUG.2019 15:03:43

Highest channel

LTE Band 5: -26dBc bandwidth
BW: 1.4MHz

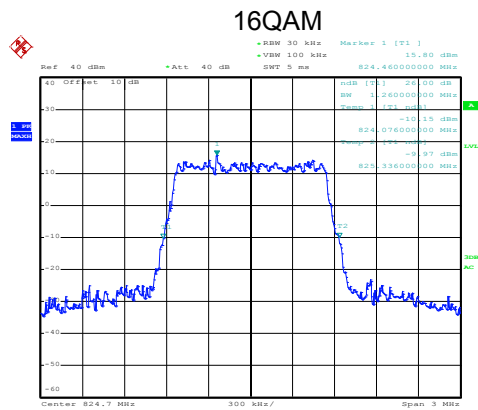


Date: 20.AUG.2019 14:58:28

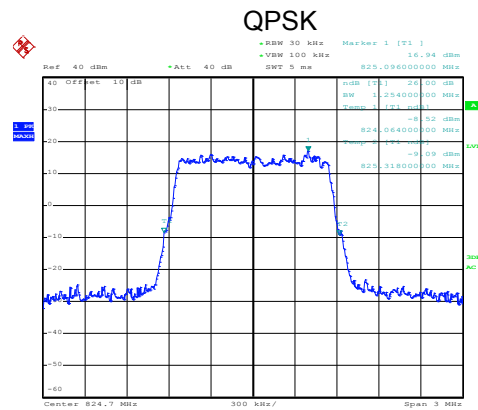


Date: 20.AUG.2019 14:58:23

Lowest channel

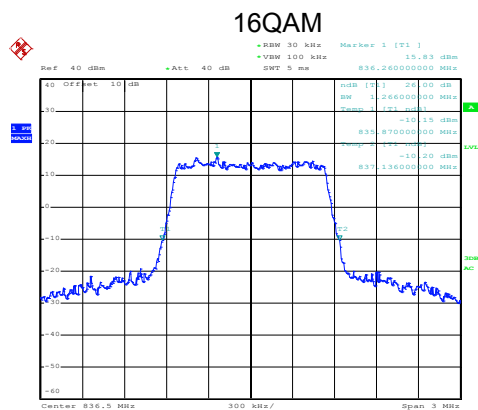


Date: 20.AUG.2019 14:57:52

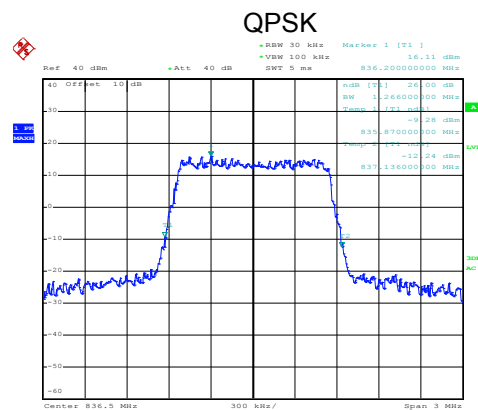


Date: 20.AUG.2019 14:57:47

Middle channel



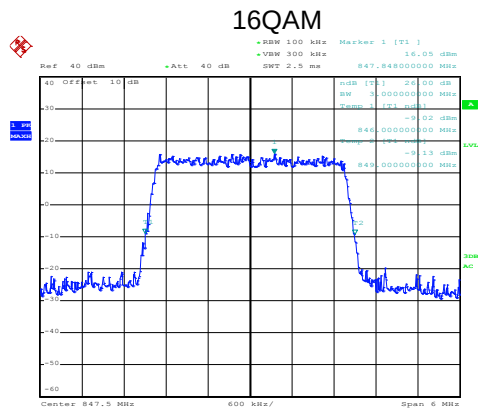
Date: 20.AUG.2019 14:57:27



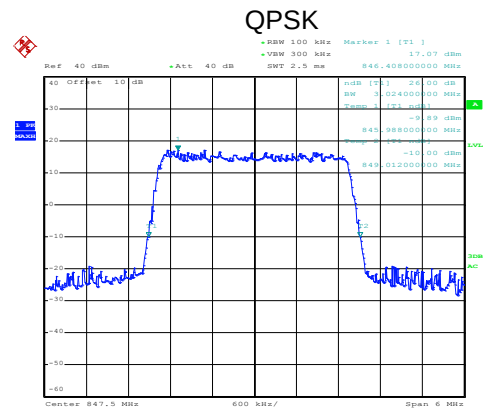
Date: 20.AUG.2019 14:57:33

Highest channel

LTE Band 5: -26dBc bandwidth
BW: 3MHz

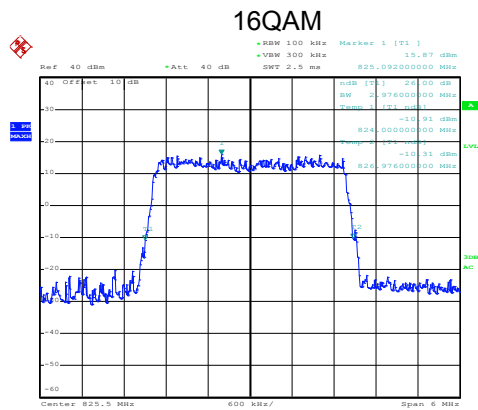


Date: 20.AUG.2019 15:00:30

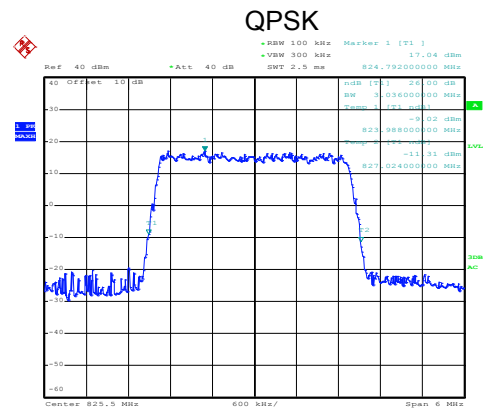


Date: 20.AUG.2019 15:00:26

Lowest channel

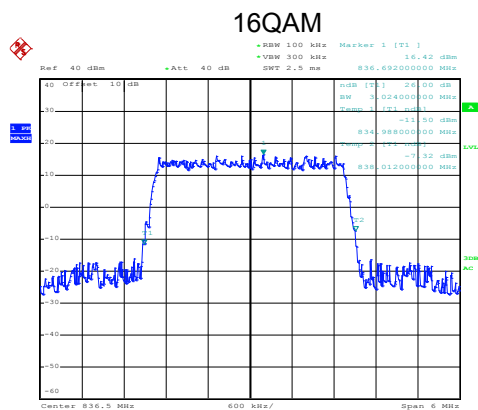


Date: 20.AUG.2019 14:59:33

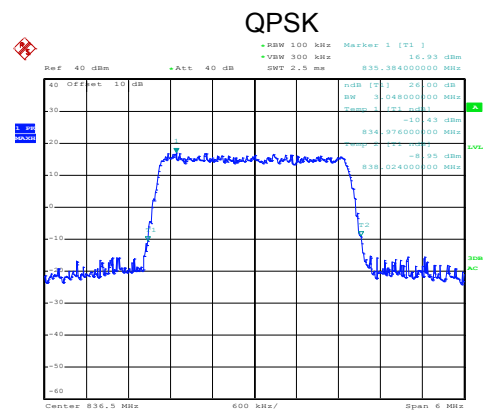


Date: 20.AUG.2019 14:59:30

Middle channel



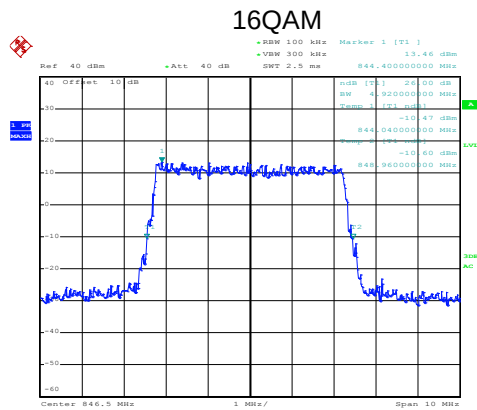
Date: 20.AUG.2019 14:59:50



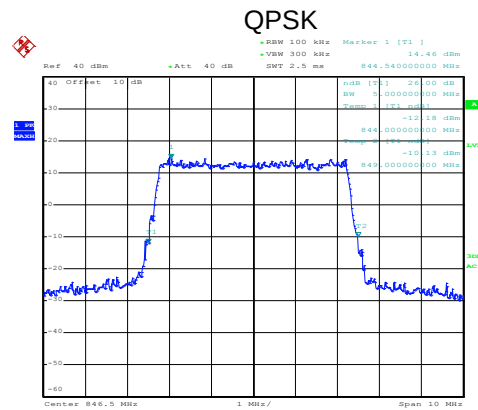
Date: 20.AUG.2019 14:59:45

Highest channel

LTE Band 5: -26dBc bandwidth
BW: 5MHz

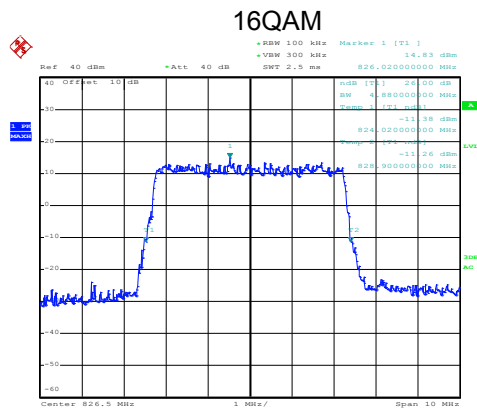


Date: 20.AUG.2019 15:02:20

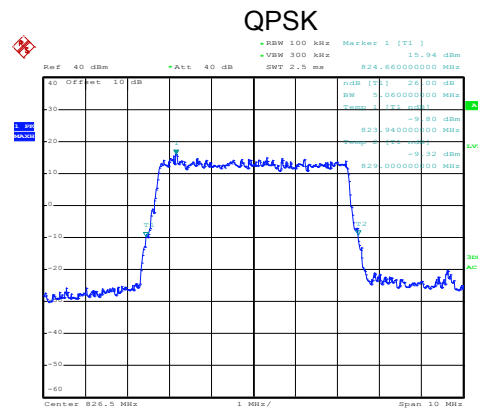


Date: 20.AUG.2019 15:02:16

Lowest channel

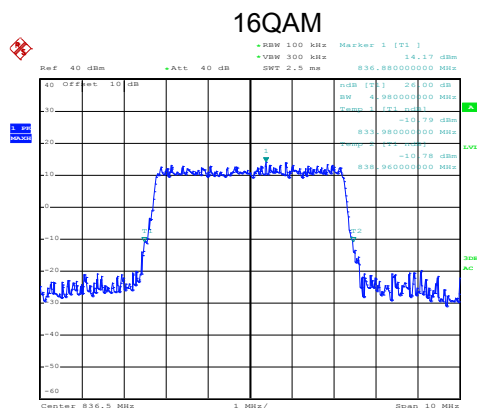


Date: 20.AUG.2019 15:01:00

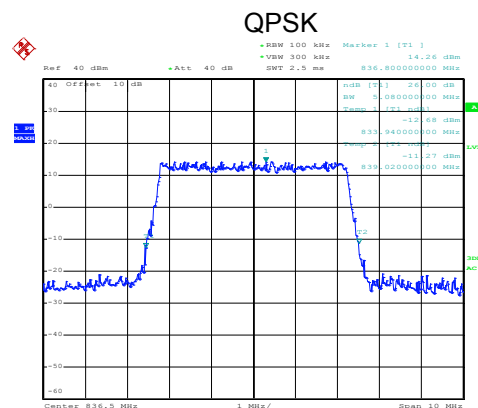


Date: 20.AUG.2019 15:00:56

Middle channel



Date: 20.AUG.2019 15:01:44

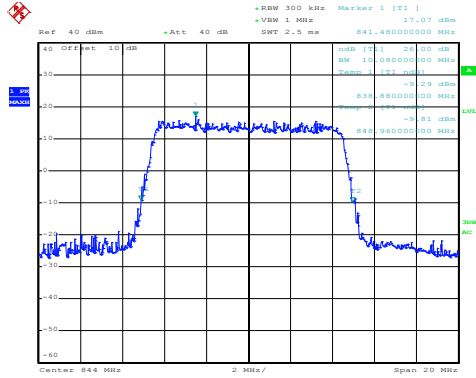


Date: 20.AUG.2019 15:01:40

Highest channel

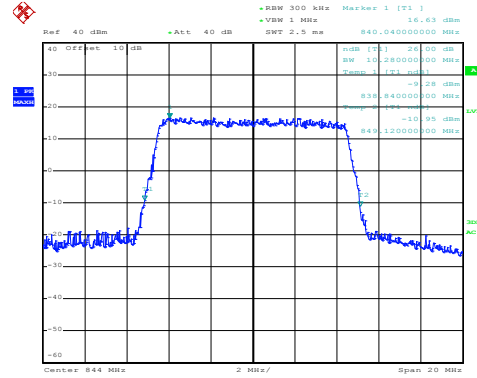
LTE Band 5: -26dBc bandwidth BW: 10MHz

16QAM



Date: 20.AUG.2019 15:04:19

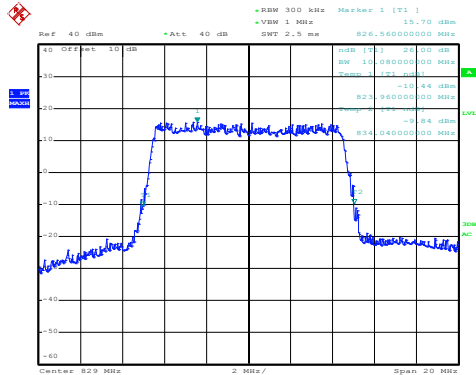
QPSK



Date: 20.AUG.2019 15:04:15

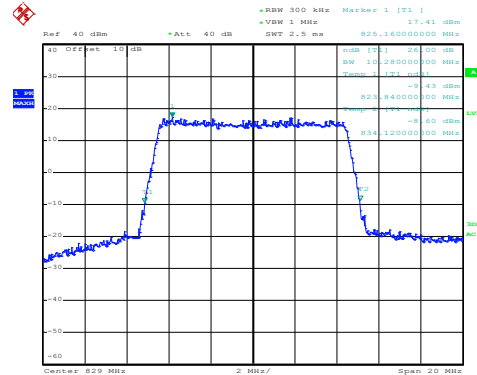
Lowest channel

16QAM



Date: 20.AUG.2019 15:03:16

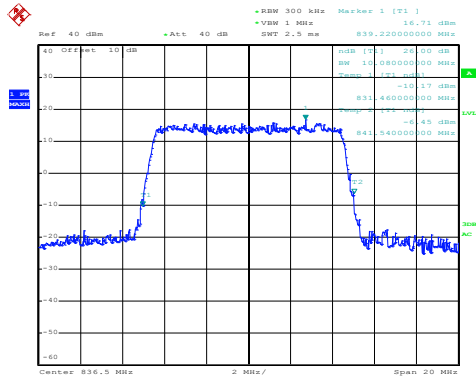
QPSK



Date: 20.AUG.2019 15:03:12

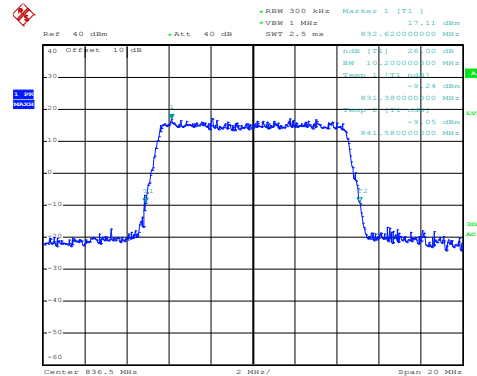
Middle channel

16QAM



Date: 20.AUG.2019 15:03:32

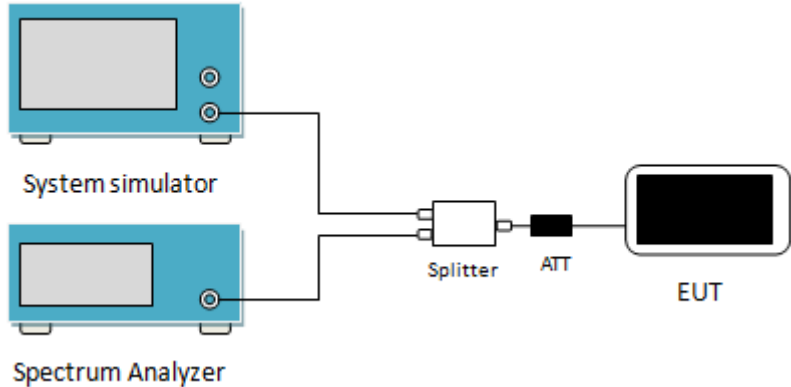
QPSK



Date: 20.AUG.2019 15:03:27

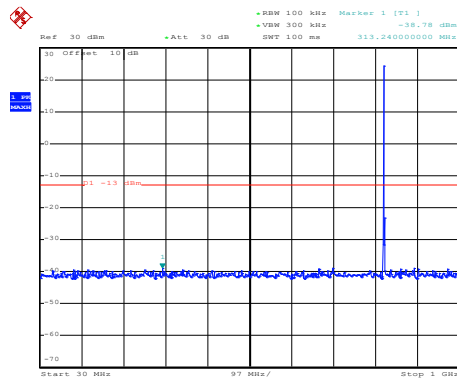
Highest channel

6.4 Out of band emission at antenna terminals

Test Requirement:	Part 22.917(b)
Test Method:	ANSI/TIA-603-D 2010
Limit:	LTE Band 5 The power of any emission outside a licensee's frequency block shall be attenuated below the transmitter power (P) in watts by at least $43 + 10 \log_{10}(P)$ dB (-13 dBm).
Test Setup:	 The diagram illustrates the test setup. On the left, there are two blue rectangular units: the top one is labeled 'System simulator' and the bottom one is labeled 'Spectrum Analyzer'. Both have a single output port. These two ports are connected to a single input port of a white rectangular unit labeled 'Splitter'. The 'Splitter' has two output ports. One output port is connected to a black rectangular unit labeled 'ATT' (Attenuator). The other output port is connected to a black rectangular unit labeled 'EUT' (Equipment Under Test).
Test Procedure:	1 The RF output of the transceiver was connected to a spectrum analyzer through appropriate attenuation. 2 The resolution bandwidth of the spectrum analyzer was set at 100 kHz when below 1GHz, 1MHz when above 1 GHz; sufficient scans were taken to show the out of band Emissions if any up to 10th harmonic. 3 For the out of band: Set the RBW=100 kHz, VBW=300 kHz when below 1 GHz, RBW =1 MHz, VBW=3 MHz when above 1 GHz, Start=30MHz, Stop= 10th harmonic. 4 Band Edge Requirements: In the 1 MHz bands immediately outside and adjacent to the frequency block, a resolution bandwidth of at least 1 percent of the emission bandwidth of the fundamental emission of the transmitter may be employed to measure the out of band Emissions.
Test Instruments:	Refer to section 5.9 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed
Remark:	Pre-scan all RB Size and offset, and found the RB Size and offset of worst case, so the report shows only the worst case test data.

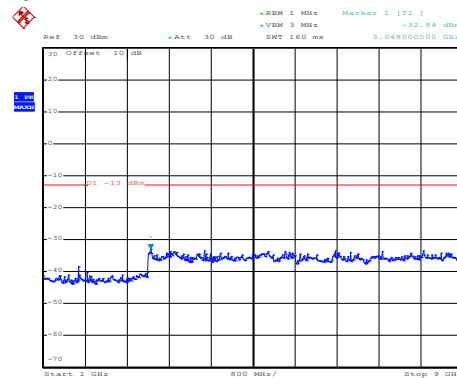
Test plots as follows (Conducted spurious emission) (worst case):
LTE Band 5 part:

LTE Band 5: 16 QAM & RB Size 1 BW: 1.4MHz Lowest channel



Date: 20.AUG.2019 15:23:32

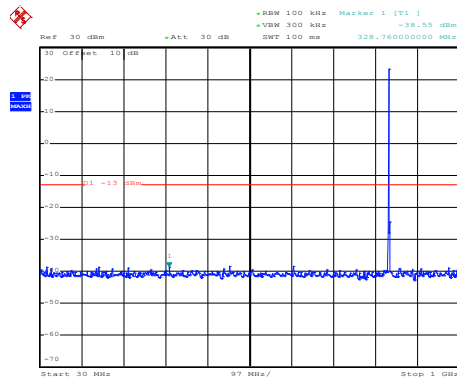
30MHz~1GHz



Date: 20.AUG.2019 15:42:52

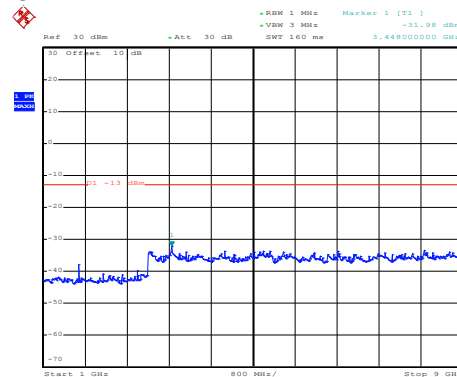
1GHz~9GHz

Middle channel



Date: 20.AUG.2019 15:24:56

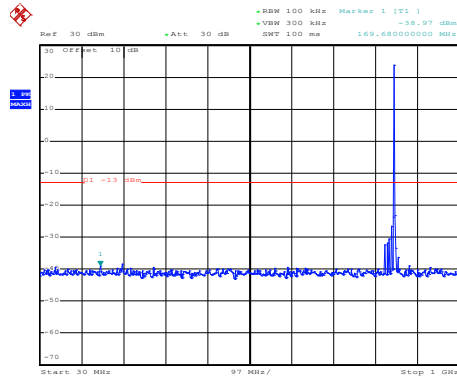
30MHz~1GHz



Date: 20.AUG.2019 15:43:58

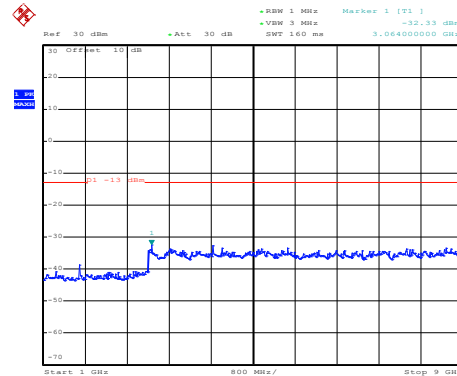
1GHz~9GHz

High channel



Date: 20.AUG.2019 15:25:23

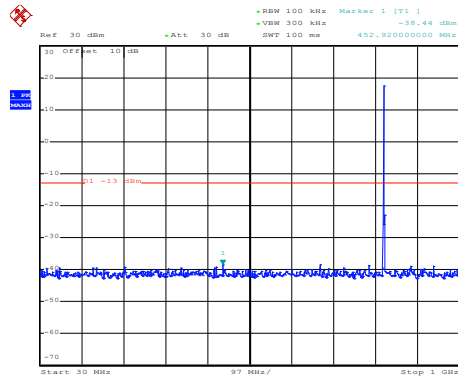
30MHz~1GHz



Date: 20.AUG.2019 15:44:30

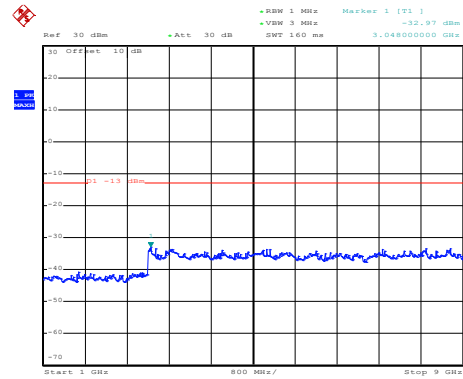
1GHz~9GHz

LTE Band 5: 16 QAM & RB Size 6 BW: 1.4MHz Lowest channel



Date: 20.AUG.2019 15:23:55

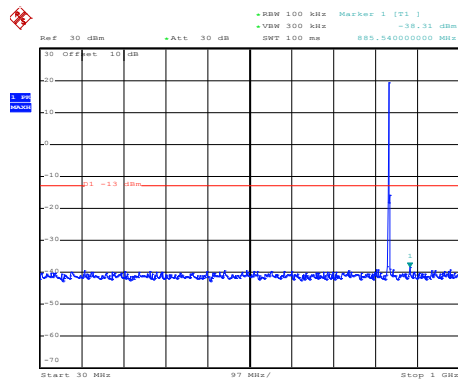
30MHz~1GHz



Date: 20.AUG.2019 15:43:16

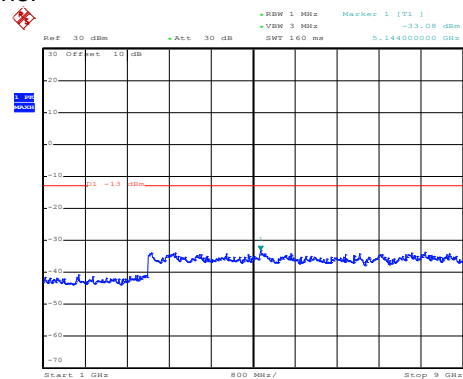
1GHz~9GHz

Middle channel



Date: 20.AUG.2019 15:24:29

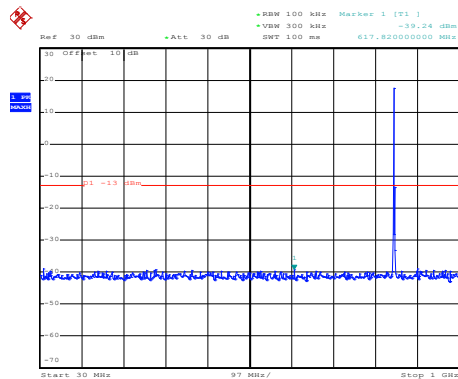
30MHz~1GHz



Date: 20.AUG.2019 15:43:38

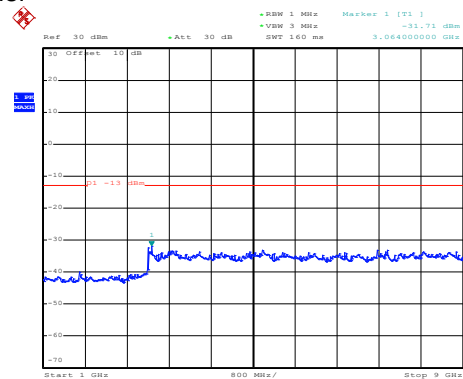
1GHz~9GHz

High channel



Date: 20.AUG.2019 15:25:50

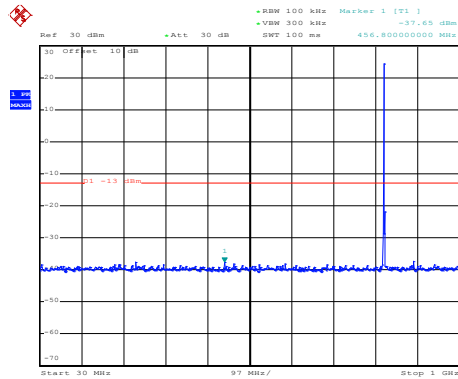
30MHz~1GHz



Date: 20.AUG.2019 15:53:32

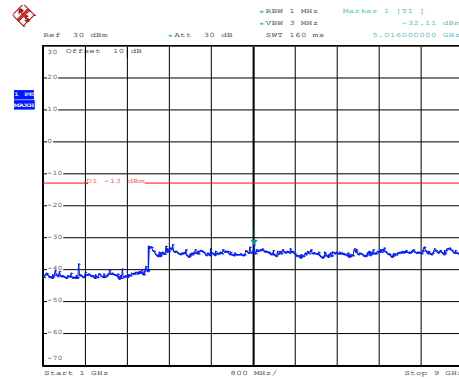
1GHz~9GHz

LTE Band 5: QPSK & RB Size 1 BW: 1.4MHz Lowest channel



Date: 20.AUG.2019 15:23:20

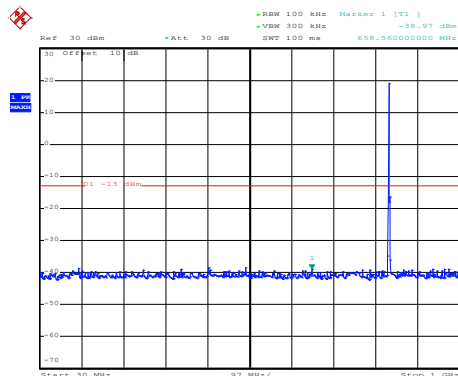
30MHz~1GHz



Date: 20.AUG.2019 15:42:42

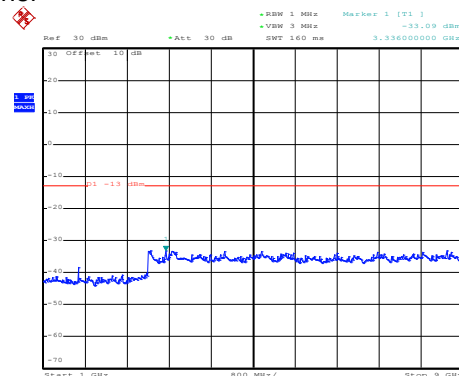
1GHz~9GHz

Middle channel



Date: 20.AUG.2019 15:24:16

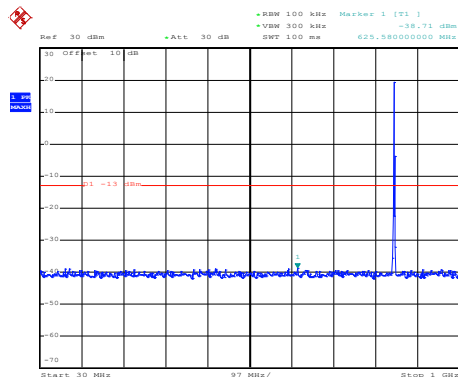
30MHz~1GHz



Date: 20.AUG.2019 15:43:50

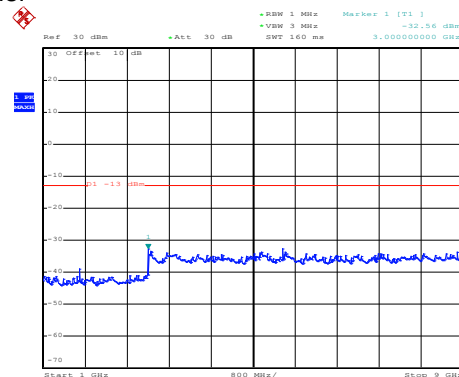
1GHz~9GHz

High channel



Date: 20.AUG.2019 15:25:40

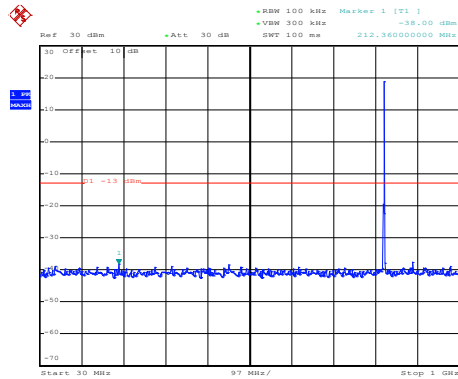
30MHz~1GHz



Date: 20.AUG.2019 15:44:19

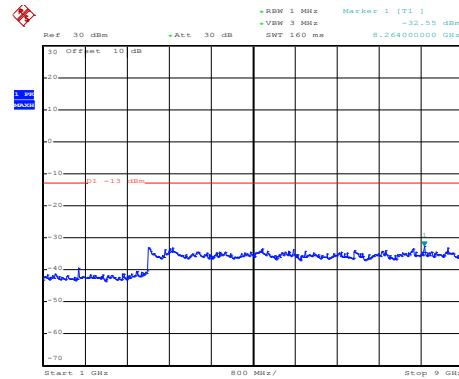
1GHz~9GHz

LTE Band 5: QPSK & RB Size 6 BW: 1.4MHz Lowest channel



Date: 20.AUG.2019 15:23:45

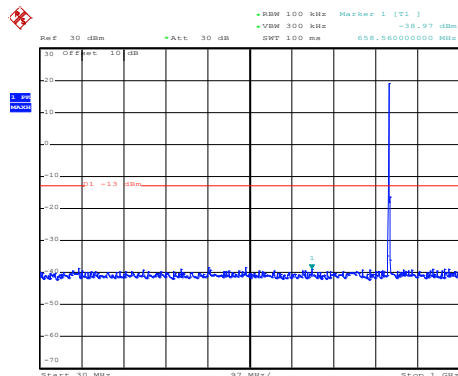
30MHz~1GHz



Date: 20.AUG.2019 15:43:06

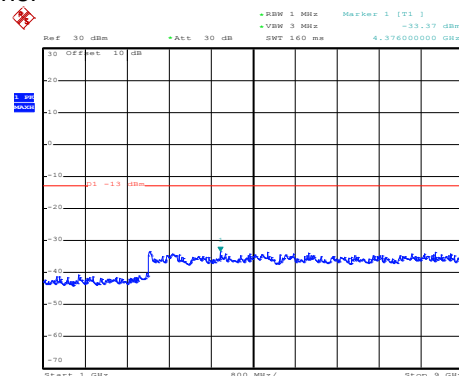
1GHz~9GHz

Middle channel



Date: 20.AUG.2019 15:24:16

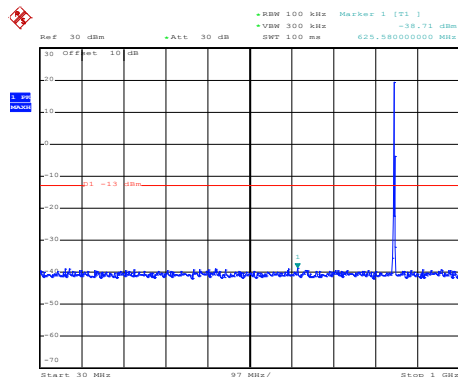
30MHz~1GHz



Date: 20.AUG.2019 15:43:30

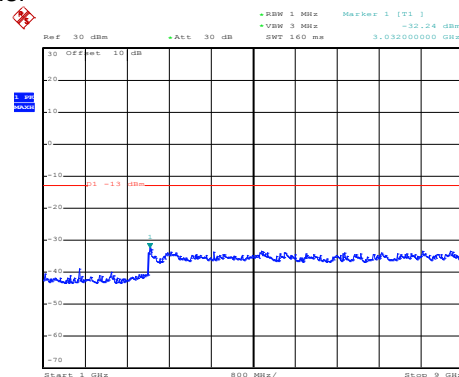
1GHz~9GHz

High channel



Date: 20.AUG.2019 15:25:40

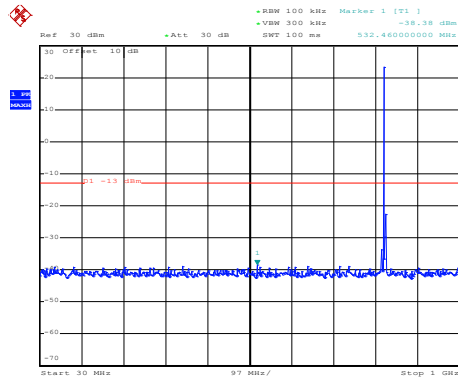
30MHz~1GHz



Date: 20.AUG.2019 15:44:43

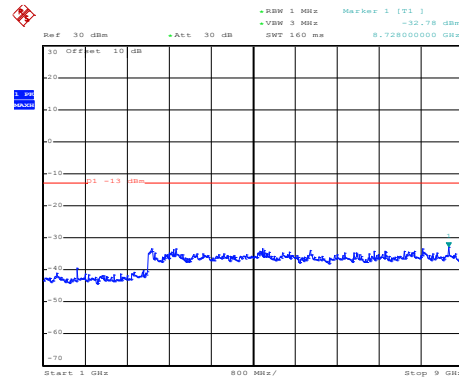
1GHz~9GHz

LTE Band 5: 16 QAM & RB Size 1 BW: 3MHz Lowest channel



Date: 20.AUG.2019 15:26:29

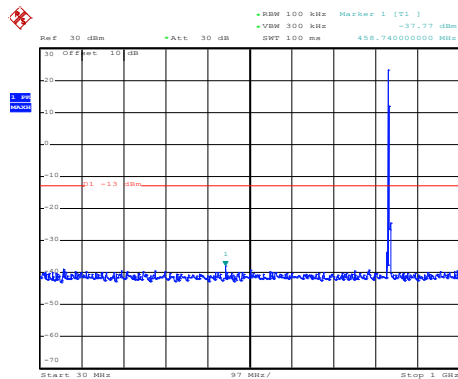
30MHz~1GHz



Date: 20.AUG.2019 15:45:26

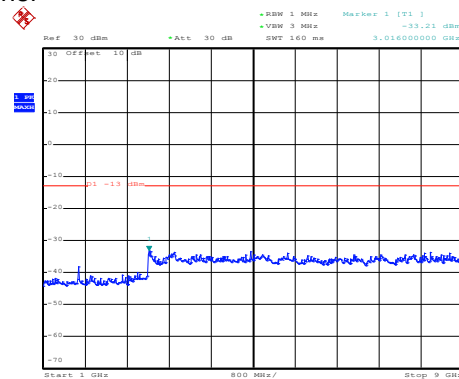
1GHz~9GHz

Middle channel



Date: 20.AUG.2019 15:27:56

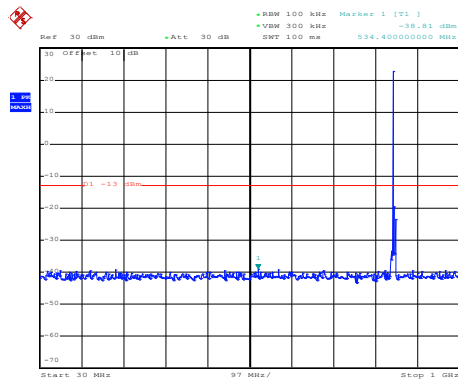
30MHz~1GHz



Date: 20.AUG.2019 15:46:24

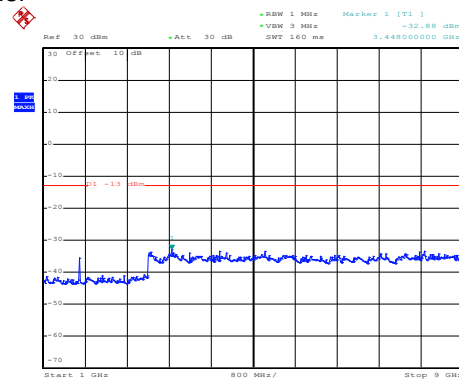
1GHz~9GHz

High channel



Date: 20.AUG.2019 15:28:27

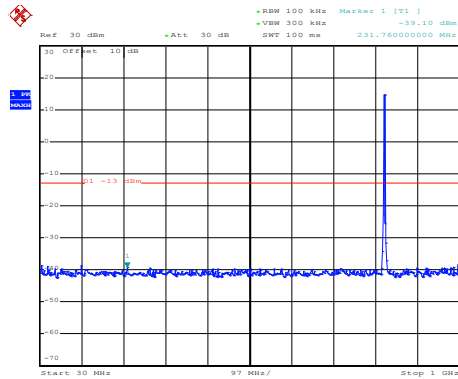
30MHz~1GHz



Date: 20.AUG.2019 15:47:04

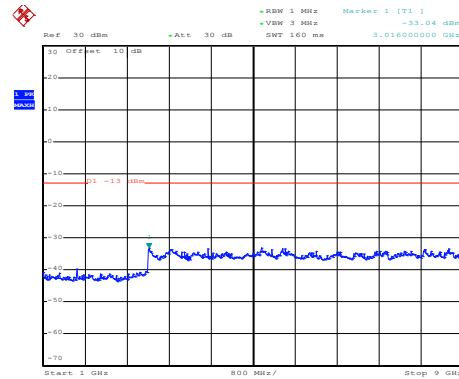
1GHz~9GHz

LTE Band 5: 16 QAM & RB Size 15 BW: 3MHz Lowest channel



Date: 20.AUG.2019 15:26:58

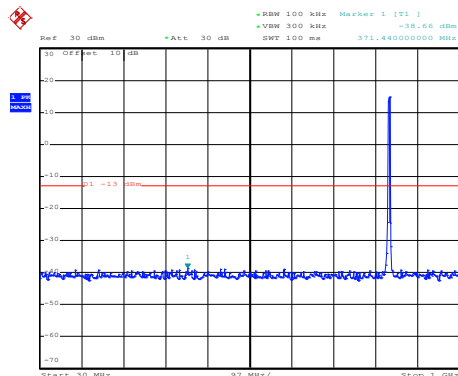
30MHz~1GHz



Date: 20.AUG.2019 15:45:49

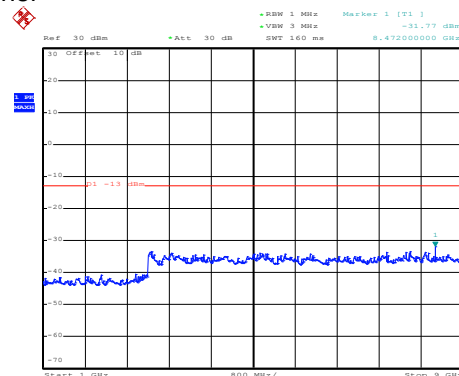
1GHz~9GHz

Middle channel



Date: 20.AUG.2019 15:27:35

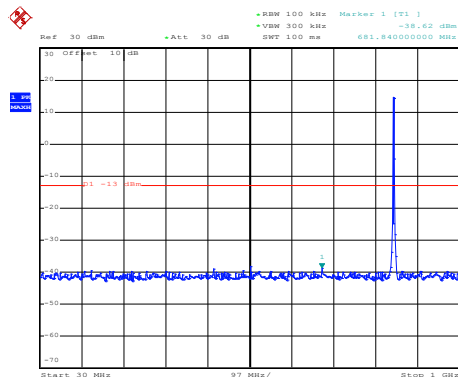
30MHz~1GHz



Date: 20.AUG.2019 15:46:07

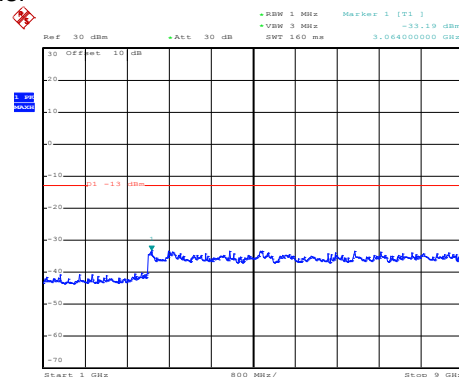
1GHz~9GHz

High channel



Date: 20.AUG.2019 15:28:50

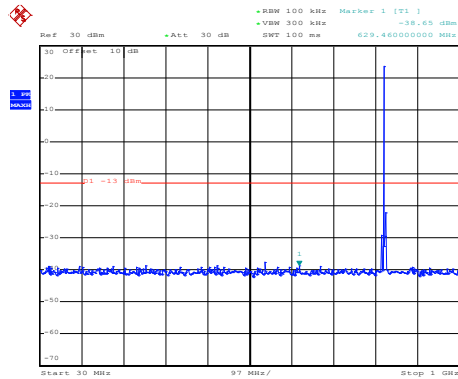
30MHz~1GHz



Date: 20.AUG.2019 15:47:24

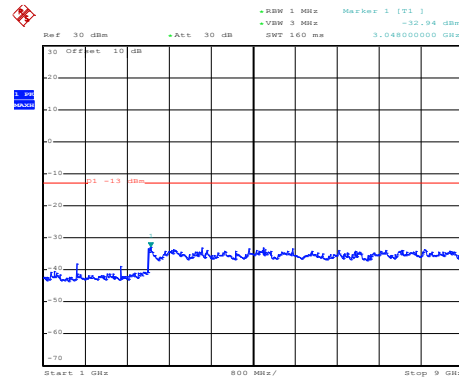
1GHz~9GHz

LTE Band 5: QPSK & RB Size 1 BW: 3MHz Lowest channel



Date: 20.AUG.2019 15:26:22

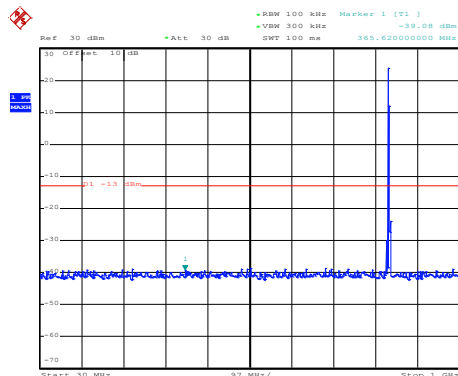
30MHz~1GHz



Date: 20.AUG.2019 15:45:20

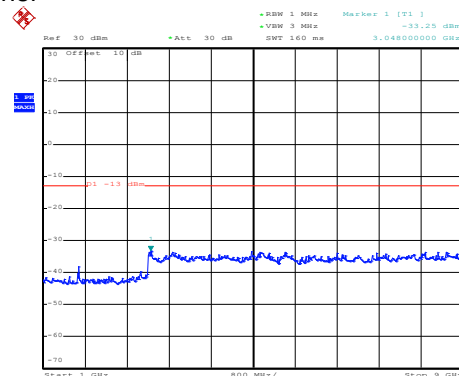
1GHz~9GHz

Middle channel



Date: 20.AUG.2019 15:27:48

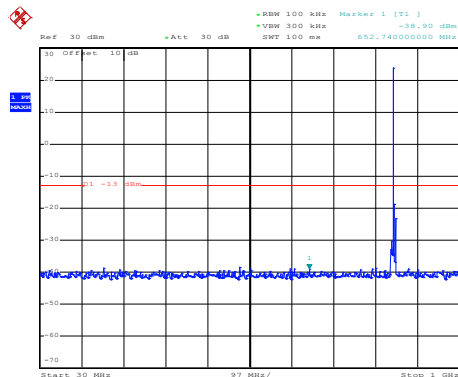
30MHz~1GHz



Date: 20.AUG.2019 15:46:18

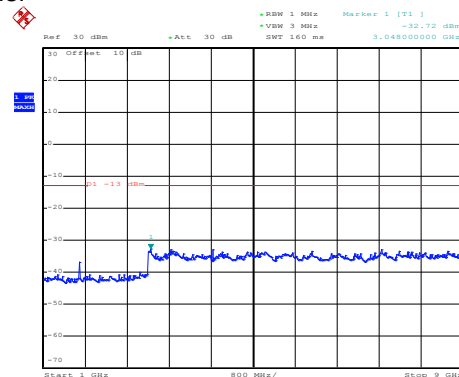
1GHz~9GHz

High channel



Date: 20.AUG.2019 15:28:19

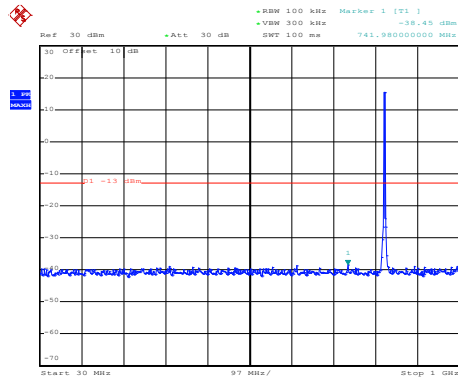
30MHz~1GHz



Date: 20.AUG.2019 15:46:56

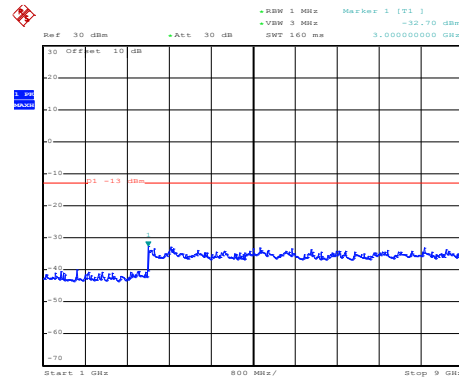
1GHz~9GHz

LTE Band 5: QPSK & RB Size 15 BW: 3MHz Lowest channel



Date: 20.AUG.2019 15:26:46

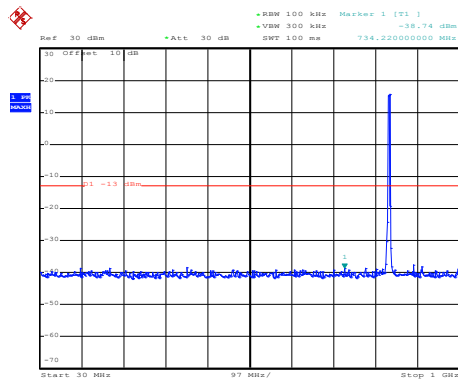
30MHz~1GHz



Date: 20.AUG.2019 15:45:37

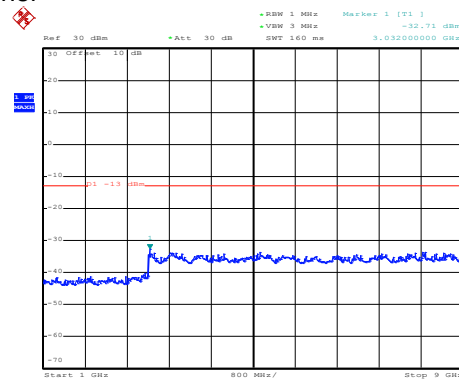
1GHz~9GHz

Middle channel



Date: 20.AUG.2019 15:27:21

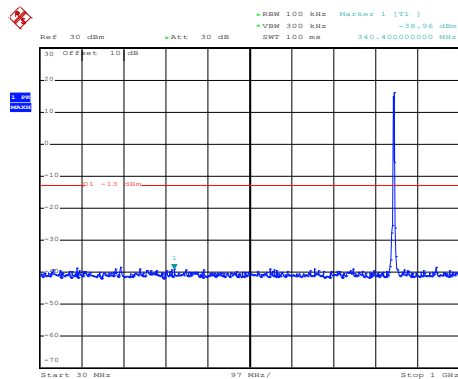
30MHz~1GHz



Date: 20.AUG.2019 15:46:01

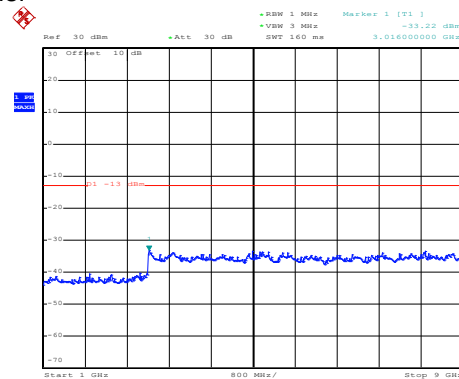
1GHz~9GHz

High channel



Date: 20.AUG.2019 15:28:42

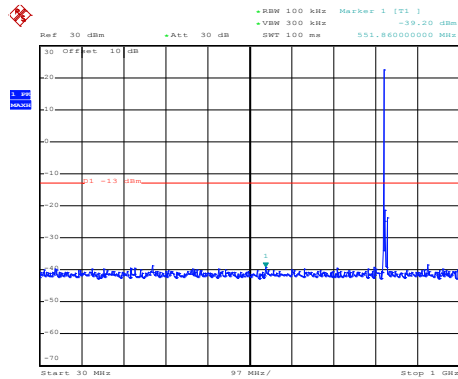
30MHz~1GHz



Date: 20.AUG.2019 15:47:14

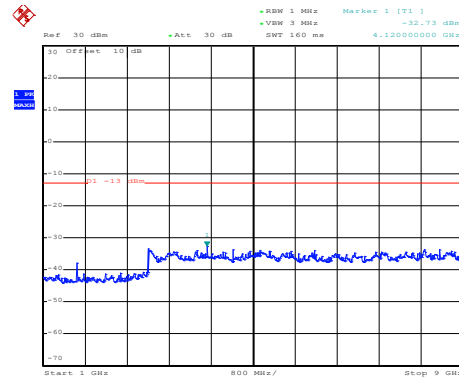
1GHz~9GHz

LTE Band 5: 16 QAM & RB Size 1 BW: 5MHz Lowest channel



Date: 20.AUG.2019 15:29:26

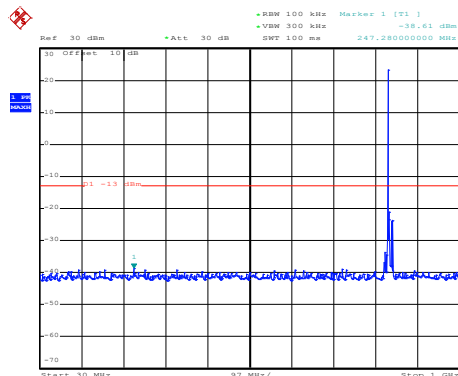
30MHz~1GHz



Date: 20.AUG.2019 15:48:03

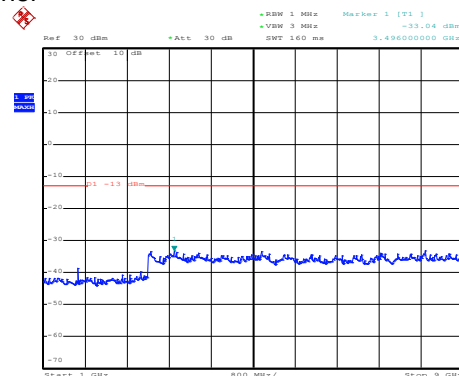
1GHz~9GHz

Middle channel



Date: 20.AUG.2019 15:30:46

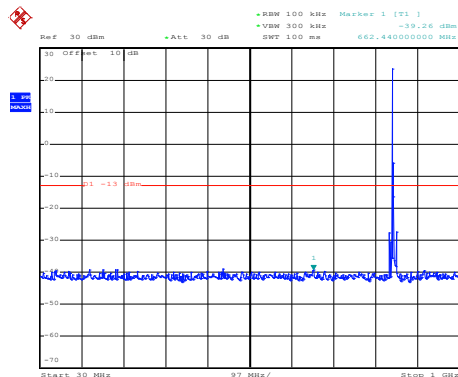
30MHz~1GHz



Date: 20.AUG.2019 15:49:00

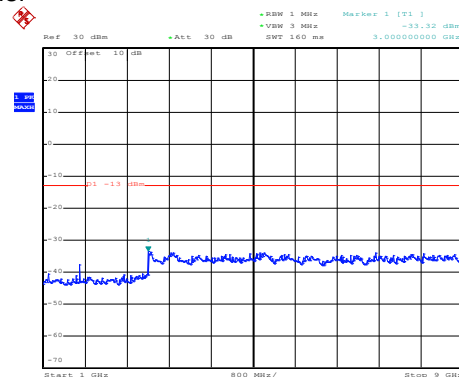
1GHz~9GHz

High channel



Date: 20.AUG.2019 15:31:16

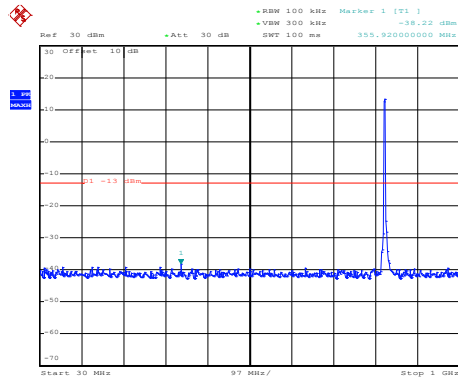
30MHz~1GHz



Date: 20.AUG.2019 15:49:18

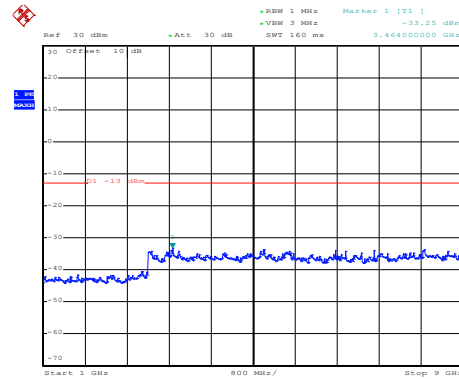
1GHz~9GHz

LTE Band 5: 16 QAM & RB Size 25 BW: 5MHz Lowest channel



Date: 20.AUG.2019 15:29:50

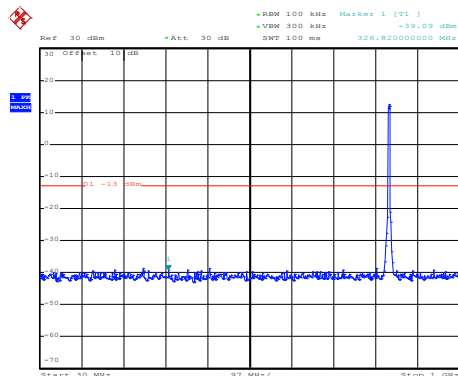
30MHz~1GHz



Date: 20.AUG.2019 15:48:21

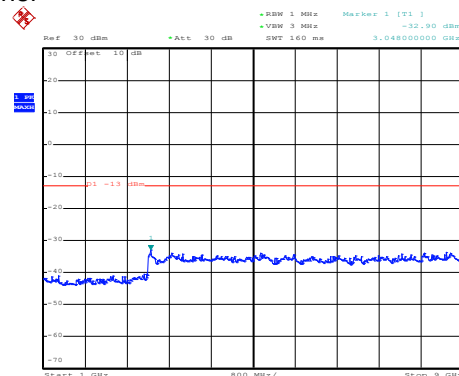
1GHz~9GHz

Middle channel



Date: 20.AUG.2019 15:30:21

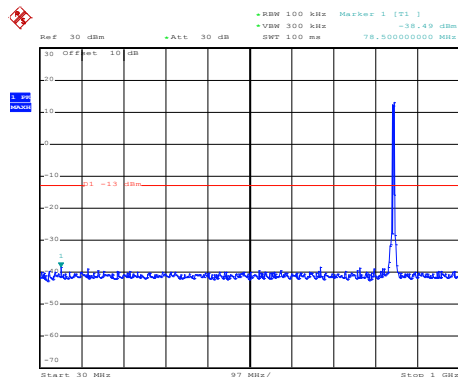
30MHz~1GHz



Date: 20.AUG.2019 15:48:41

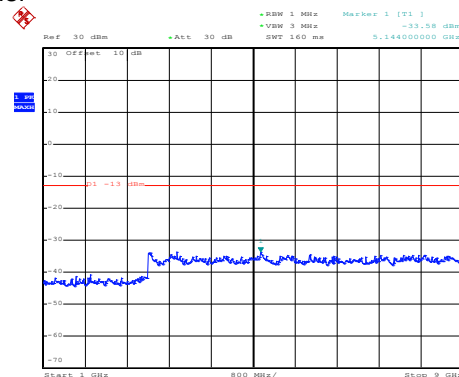
1GHz~9GHz

High channel



Date: 20.AUG.2019 15:31:41

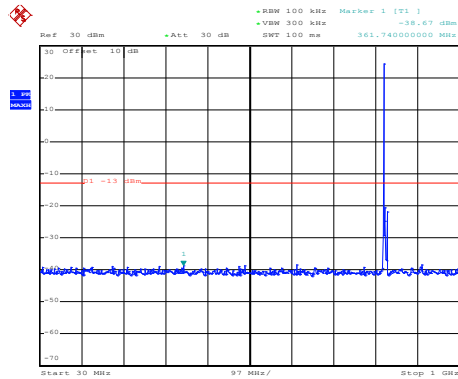
30MHz~1GHz



Date: 20.AUG.2019 15:49:37

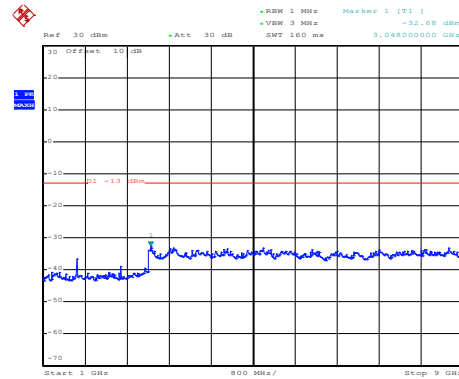
1GHz~9GHz

LTE Band 5: QPSK & RB Size 1 BW: 5MHz Lowest channel



Date: 20.AUG.2019 15:29:20

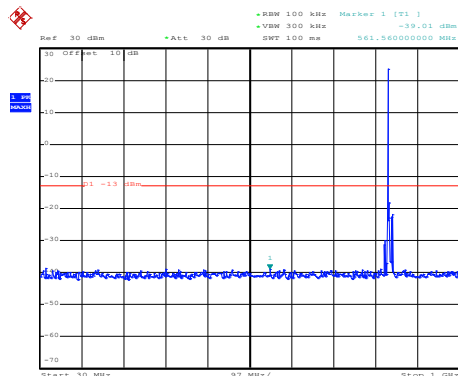
30MHz~1GHz



Date: 20.AUG.2019 15:47:58

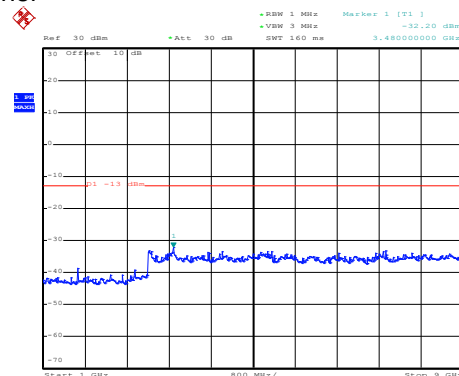
1GHz~9GHz

Middle channel



Date: 20.AUG.2019 15:30:36

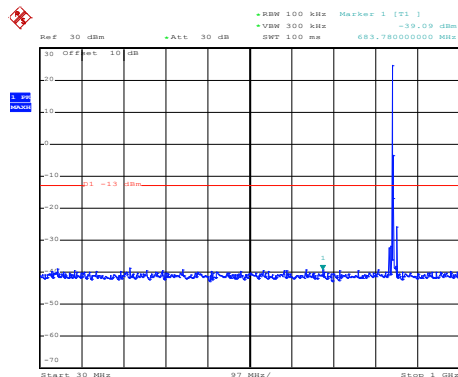
30MHz~1GHz



Date: 20.AUG.2019 15:48:52

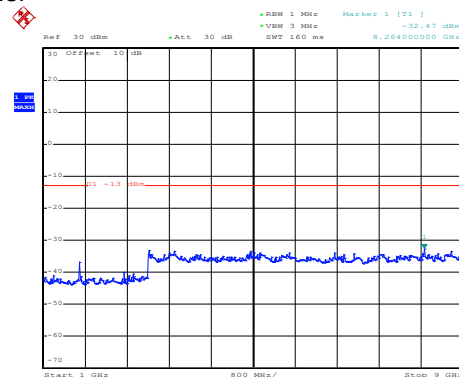
1GHz~9GHz

High channel



Date: 20.AUG.2019 15:31:10

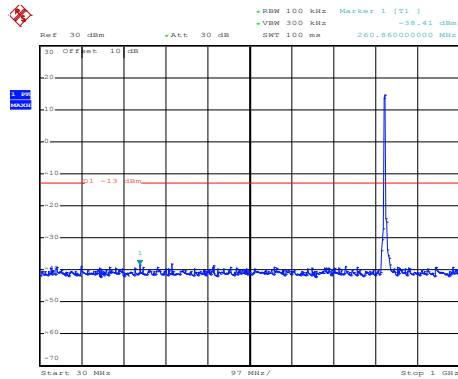
30MHz~1GHz



Date: 20.AUG.2019 15:49:12

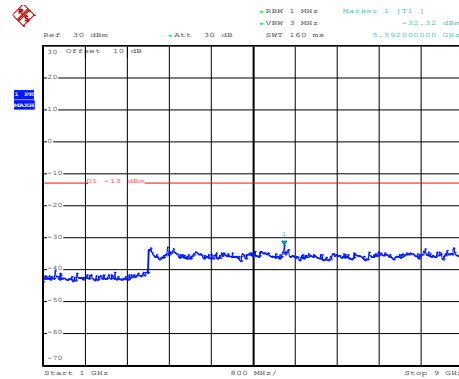
1GHz~9GHz

LTE Band 5: QPSK & RB Size 25 BW: 5MHz Lowest channel



Date: 20.AUG.2019 15:29:42

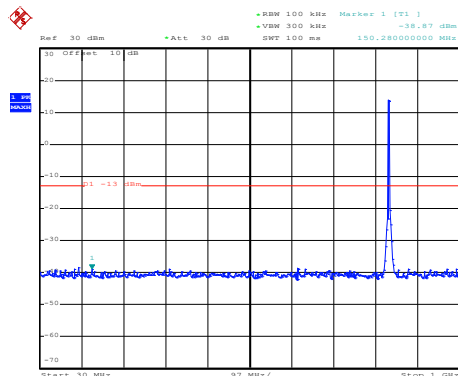
30MHz~1GHz



Date: 20.AUG.2019 15:48:15

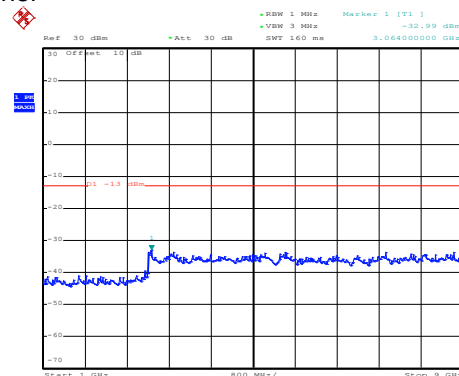
1GHz~9GHz

Middle channel



Date: 20.AUG.2019 15:30:11

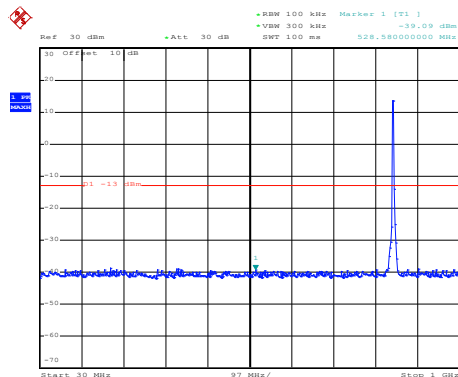
30MHz~1GHz



Date: 20.AUG.2019 15:48:33

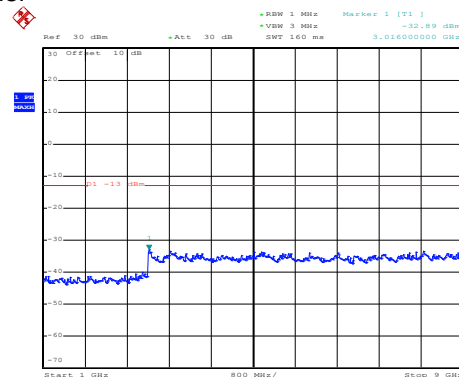
1GHz~9GHz

High channel



Date: 20.AUG.2019 15:31:31

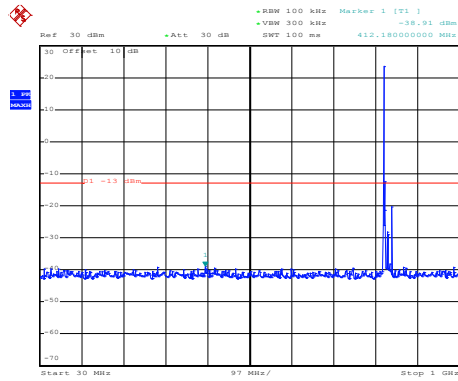
30MHz~1GHz



Date: 20.AUG.2019 15:49:31

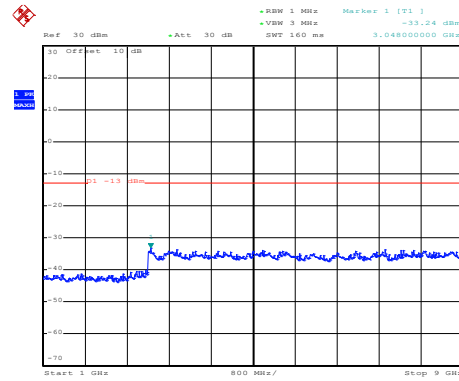
1GHz~9GHz

LTE Band 5: 16 QAM & RB Size 1 BW: 10MHz Lowest channel



Date: 20.AUG.2019 15:32:20

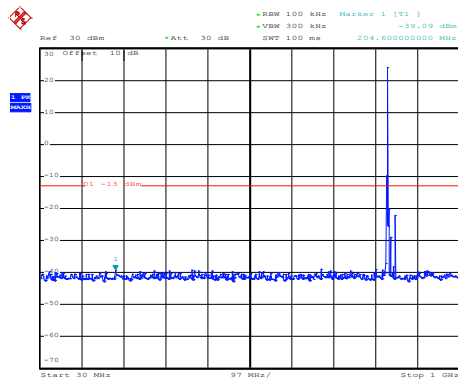
30MHz~1GHz



Date: 20.AUG.2019 15:50:21

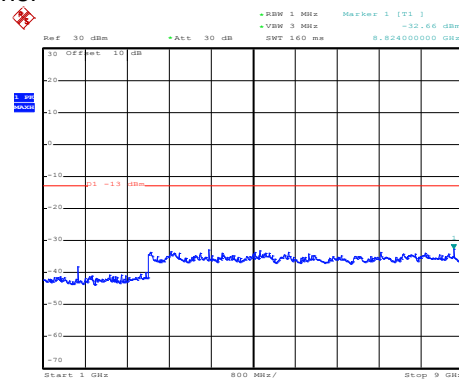
1GHz~9GHz

Middle channel



Date: 20.AUG.2019 15:33:35

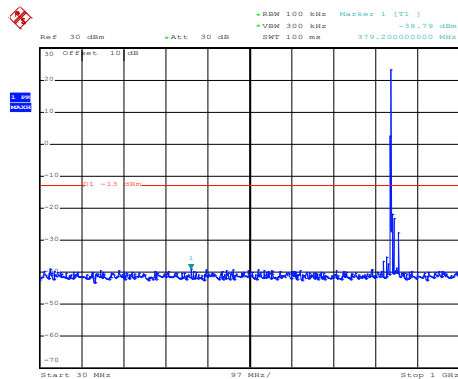
30MHz~1GHz



Date: 20.AUG.2019 15:51:33

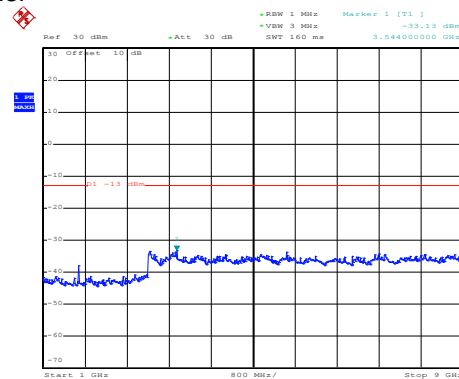
1GHz~9GHz

High channel



Date: 20.AUG.2019 15:34:02

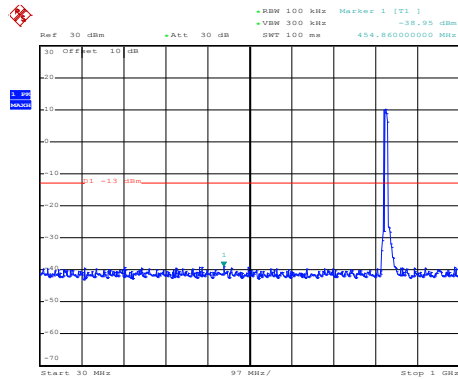
30MHz~1GHz



Date: 20.AUG.2019 15:51:54

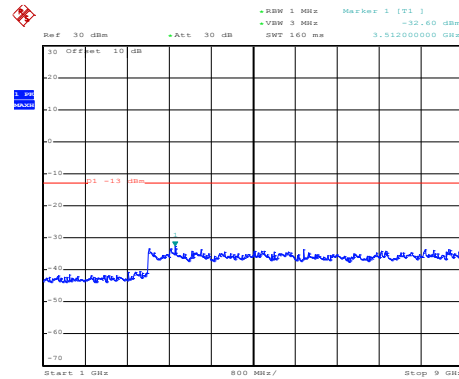
1GHz~9GHz

LTE Band 5: 16 QAM & RB Size 50 BW: 10MHz Lowest channel



Date: 20.AUG.2019 15:32:46

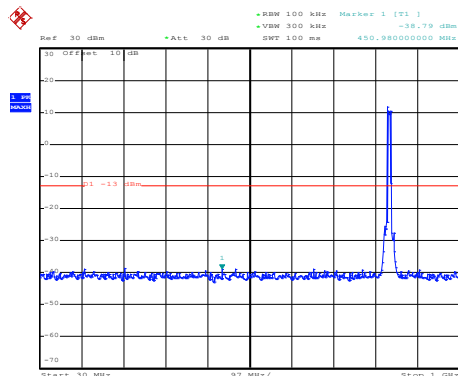
30MHz~1GHz



Date: 20.AUG.2019 15:50:43

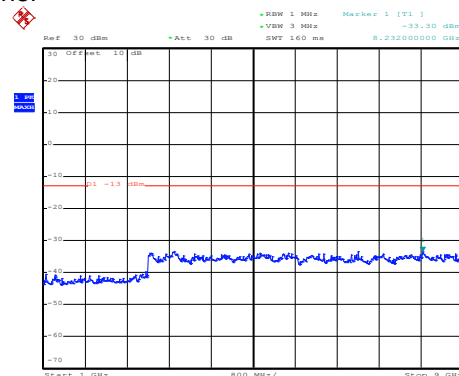
1GHz~9GHz

Middle channel



Date: 20.AUG.2019 15:33:15

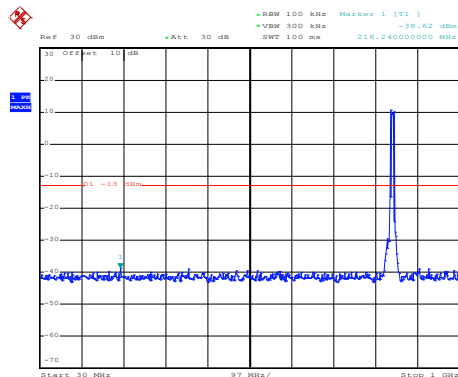
30MHz~1GHz



Date: 20.AUG.2019 15:51:10

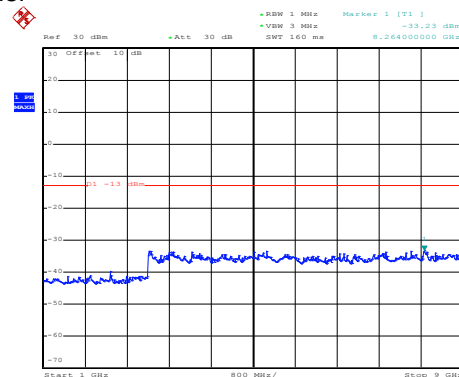
1GHz~9GHz

High channel



Date: 20.AUG.2019 15:34:22

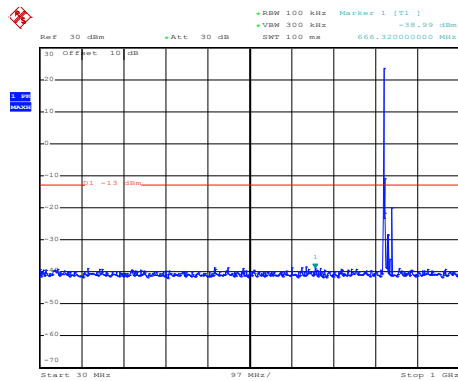
30MHz~1GHz



Date: 20.AUG.2019 15:52:20

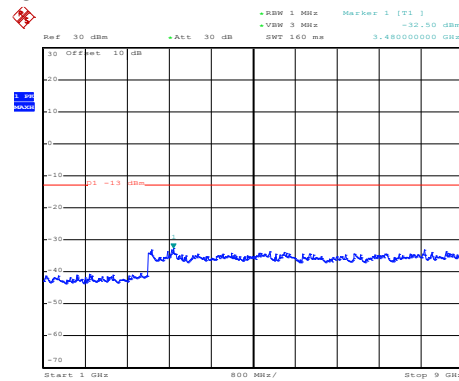
1GHz~9GHz

LTE Band 5: QPSK & RB Size 1 BW: 10MHz Lowest channel



Date: 20.AUG.2019 15:32:14

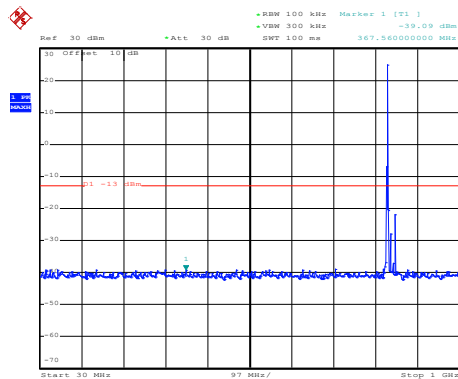
30MHz~1GHz



Date: 20.AUG.2019 15:50:12

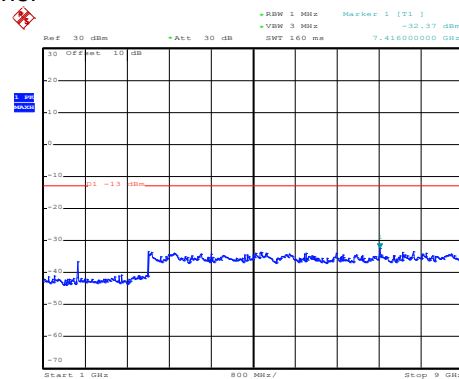
1GHz~9GHz

Middle channel



Date: 20.AUG.2019 15:33:27

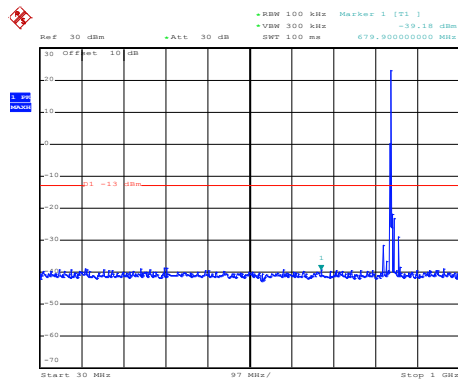
30MHz~1GHz



Date: 20.AUG.2019 15:51:23

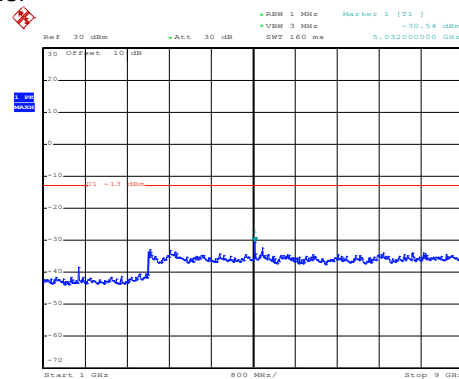
1GHz~9GHz

High channel



Date: 20.AUG.2019 15:33:53

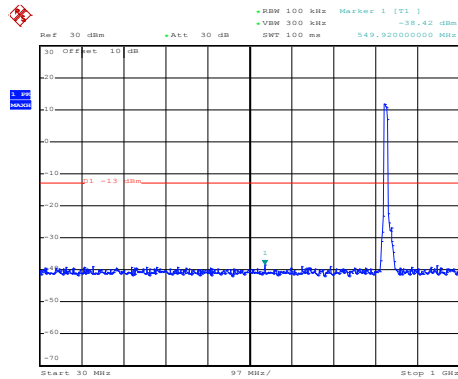
30MHz~1GHz



Date: 20.AUG.2019 15:51:48

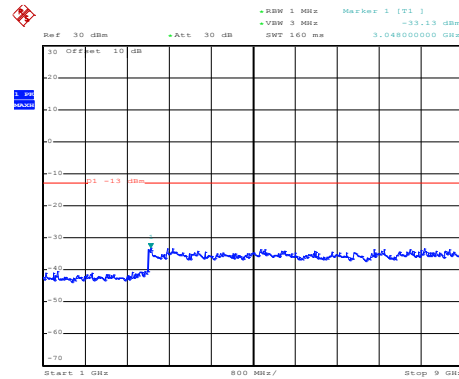
1GHz~9GHz

LTE Band 5: QPSK & RB Size 50 BW: 10MHz Lowest channel



Date: 20.AUG.2019 15:32:36

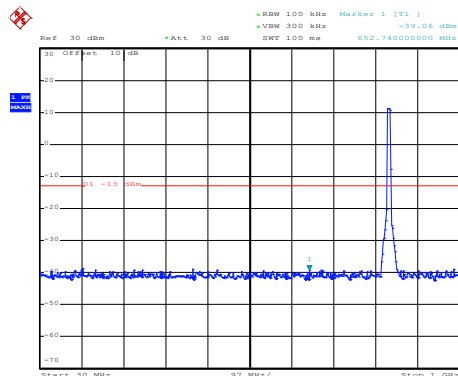
30MHz~1GHz



Date: 20.AUG.2019 15:50:34

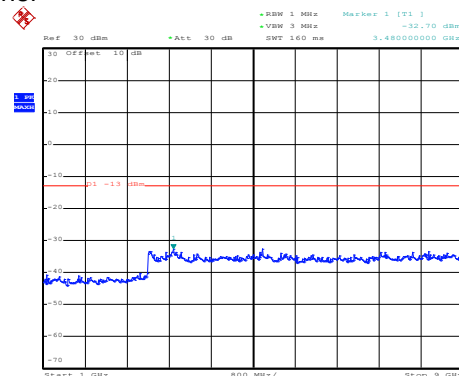
1GHz~9GHz

Middle channel



Date: 20.AUG.2019 15:33:05

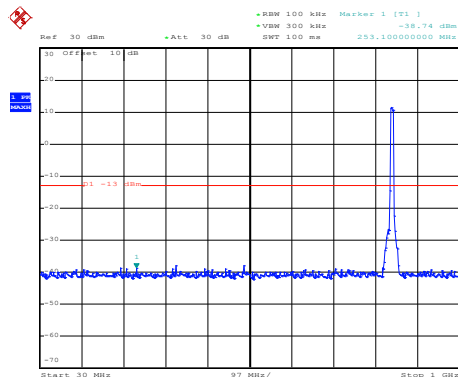
30MHz~1GHz



Date: 20.AUG.2019 15:50:59

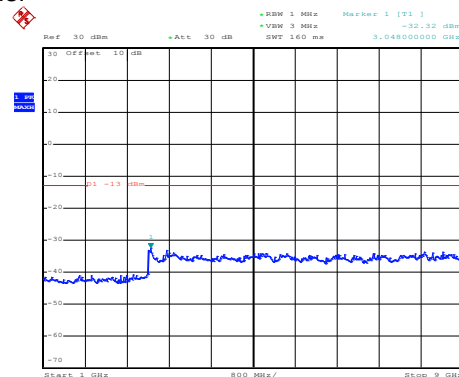
1GHz~9GHz

High channel



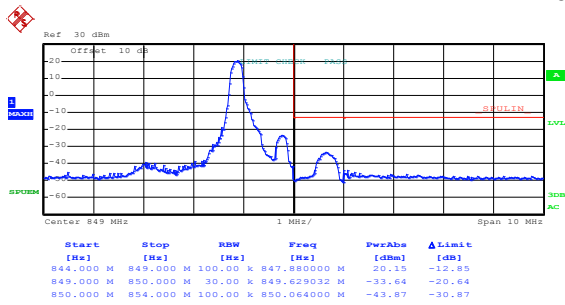
Date: 20.AUG.2019 15:34:15

30MHz~1GHz



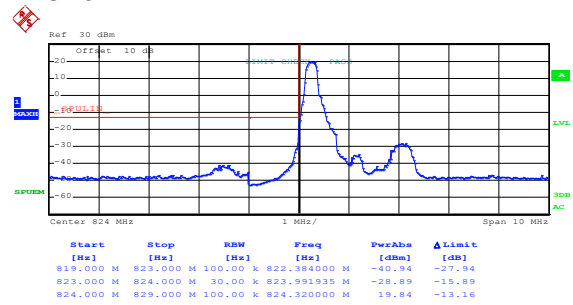
Date: 20.AUG.2019 15:52:08

1GHz~9GHz

Band edge emission:**LTE Band 5 part:****LTE Band 5, BW: 1.4MHz
16QAM & RB Size 1**

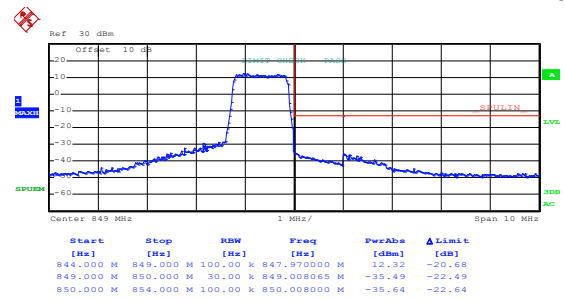
Date: 20.AUG.2019 15:10:36

Lowest channel



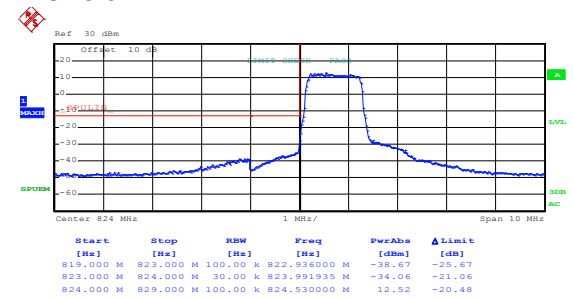
Date: 20.AUG.2019 15:11:06

Highest channel

16QAM & RB Size 6

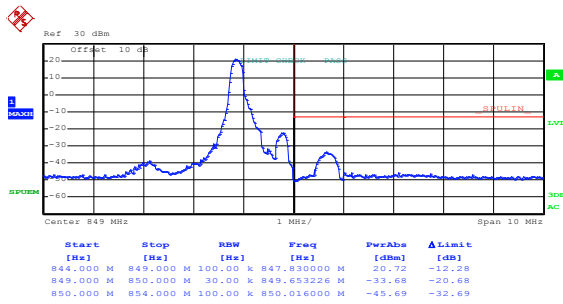
Date: 20.AUG.2019 15:10:22

Lowest channel



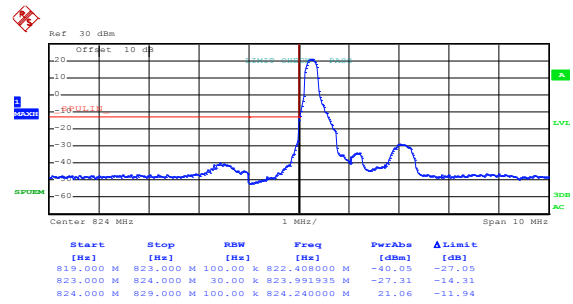
Date: 20.AUG.2019 15:11:18

Highest channel

LTE Band 5, BW: 1.4MHz
QPSK & RB Size 1

Date: 20.AUG.2019 15:10:29

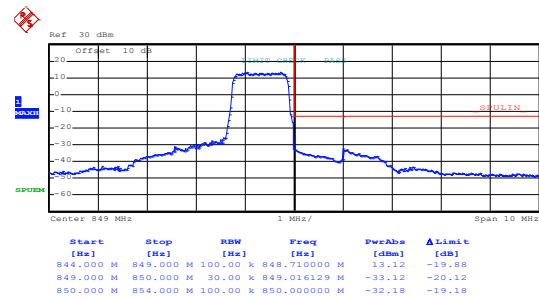
Lowest channel



Date: 20.AUG.2019 15:10:50

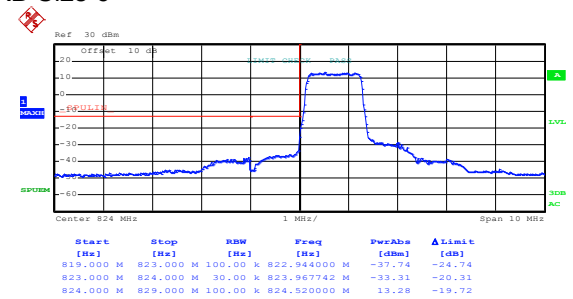
Highest channel

QPSK & RB Size 6



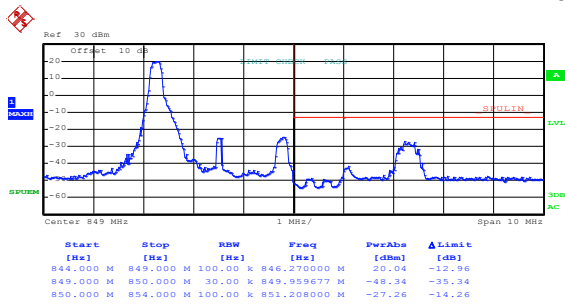
Date: 20.AUG.2019 15:10:18

Lowest channel



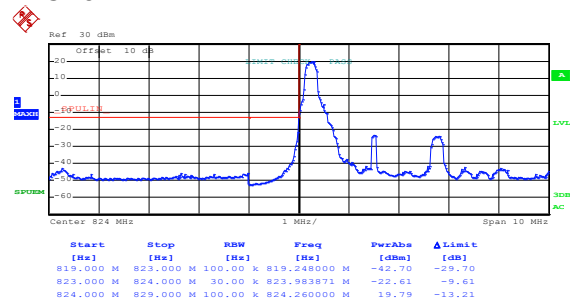
Date: 20.AUG.2019 15:11:12

Highest channel

LTE Band 5, BW: 3MHz
16QAM & RB Size 1

Date: 20.AUG.2019 15:12:34

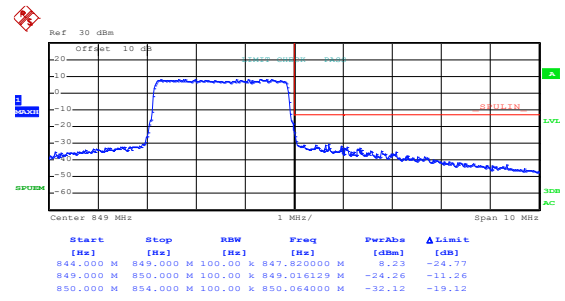
Lowest channel



Date: 20.AUG.2019 15:11:53

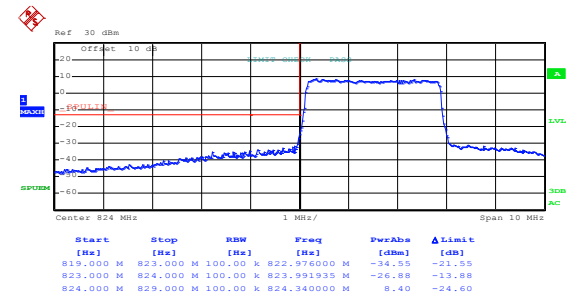
Highest channel

16QAM & RB Size 15



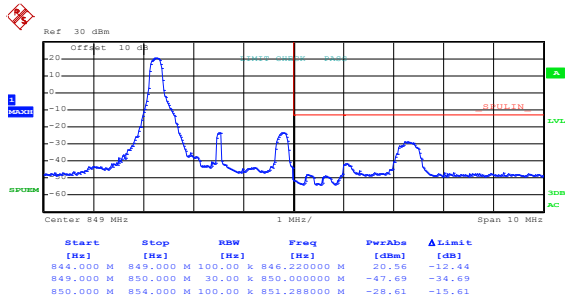
Date: 20.AUG.2019 15:12:49

Lowest channel



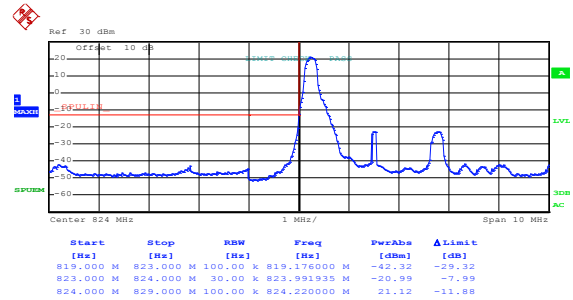
Date: 20.AUG.2019 15:12:09

Highest channel

LTE Band 5, BW: 3MHz
QPSK & RB Size 1

Date: 20.AUG.2019 15:12:29

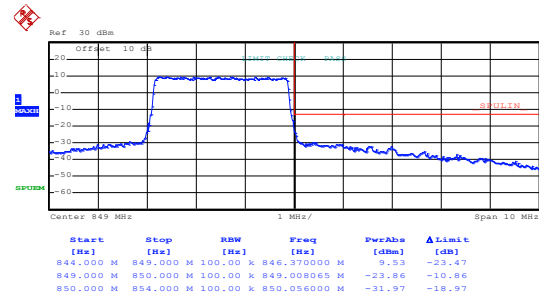
Lowest channel



Date: 20.AUG.2019 15:11:48

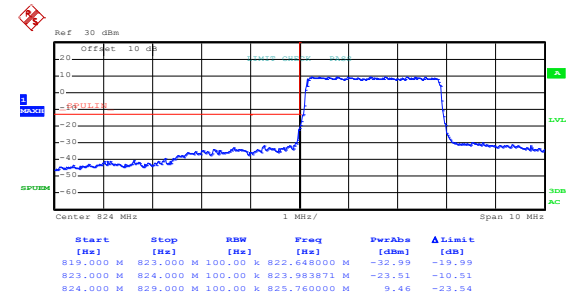
Highest channel

QPSK & RB Size 15



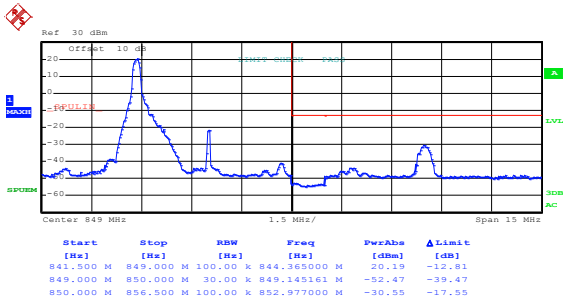
Date: 20.AUG.2019 15:12:45

Lowest channel



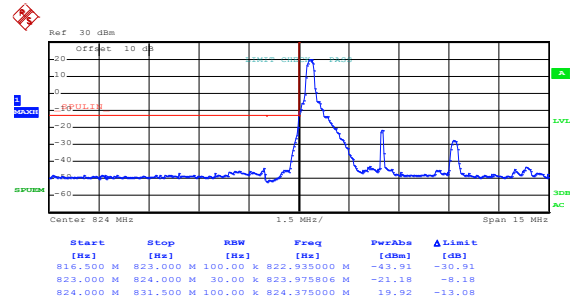
Date: 20.AUG.2019 15:12:06

Highest channel

LTE Band 5, BW: 5MHz
16QAM & RB Size 1

Date: 20.AUG.2019 15:14:52

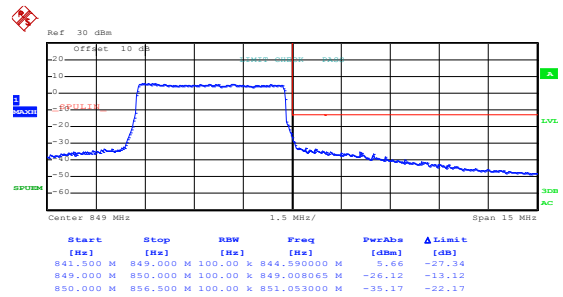
Lowest channel



Date: 20.AUG.2019 15:13:38

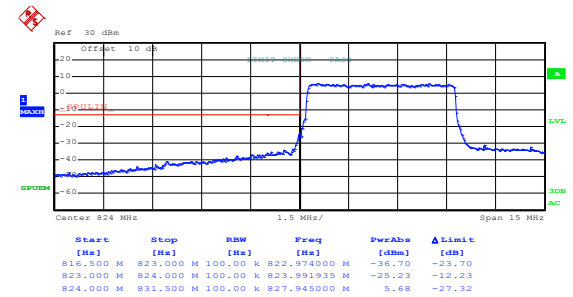
Highest channel

16QAM & RB Size 25



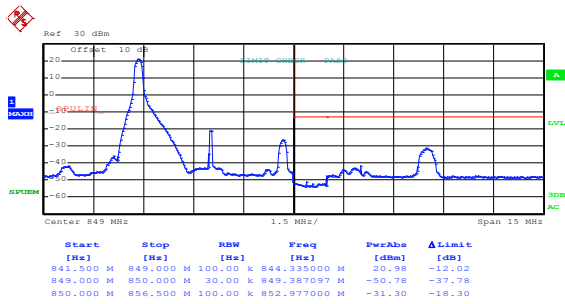
Date: 20.AUG.2019 15:15:21

Lowest channel



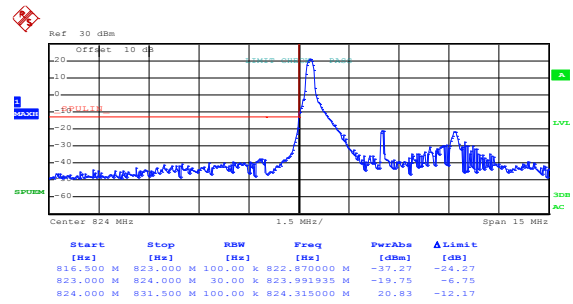
Date: 20.AUG.2019 15:13:54

Highest channel

LTE Band 5, BW: 5MHz
QPSK & RB Size 1

Date: 20.AUG.2019 15:14:44

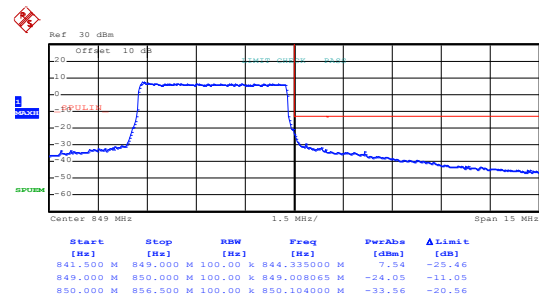
Lowest channel



Date: 20.AUG.2019 15:13:31

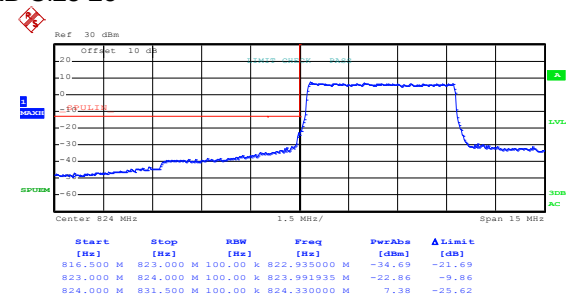
Highest channel

QPSK & RB Size 25



Date: 20.AUG.2019 15:15:17

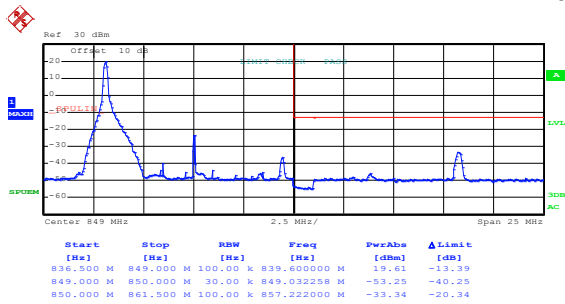
Lowest channel



Date: 20.AUG.2019 15:13:50

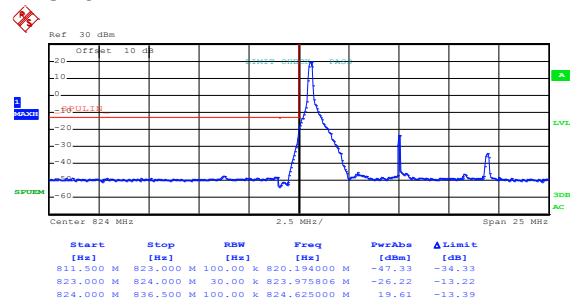
Highest channel

LTE Band 5, BW: 10MHz 16QAM & RB Size 1



Date: 20.AUG.2019 15:16:43

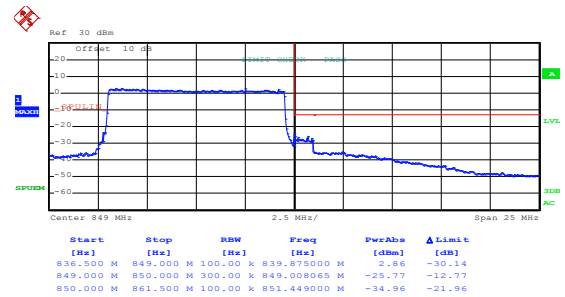
Lowest channel



Date: 20.AUG.2019 15:16:09

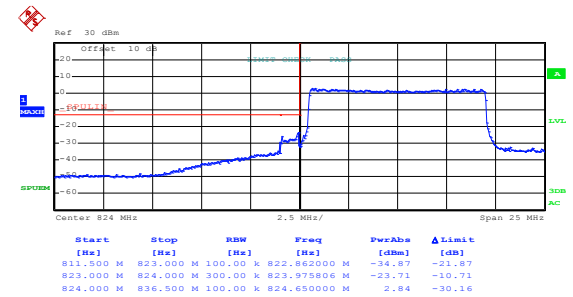
Highest channel

16QAM & RB Size 50



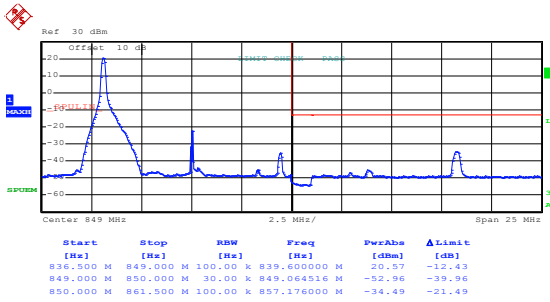
Date: 20.AUG.2019 15:16:58

Lowest channel



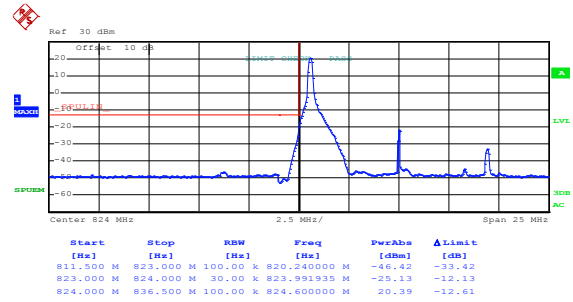
Date: 20.AUG.2019 15:16:24

Highest channel

LTE Band 5, BW: 10MHz
QPSK & RB Size 1

Date: 20.AUG.2019 15:16:38

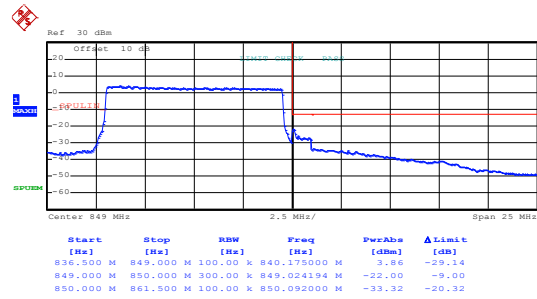
Lowest channel



Date: 20.AUG.2019 15:16:03

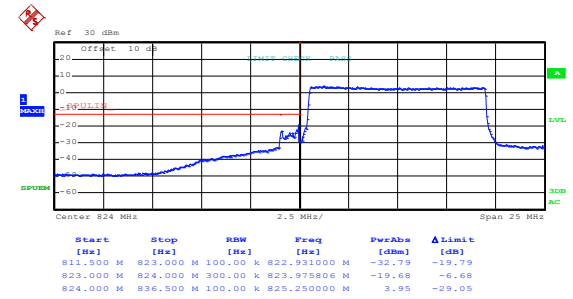
Highest channel

QPSK & RB Size 50



Date: 20.AUG.2019 15:16:54

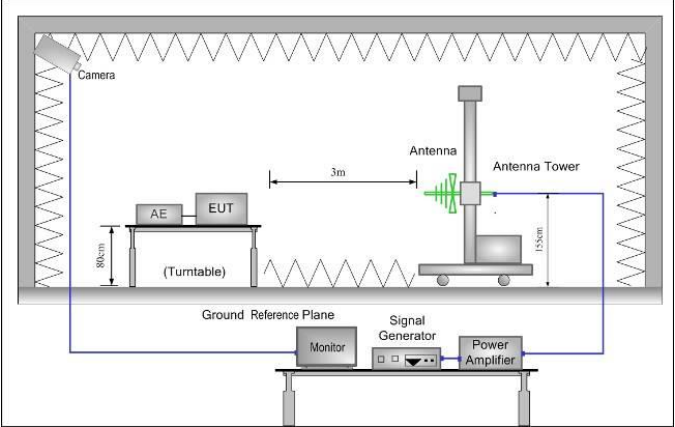
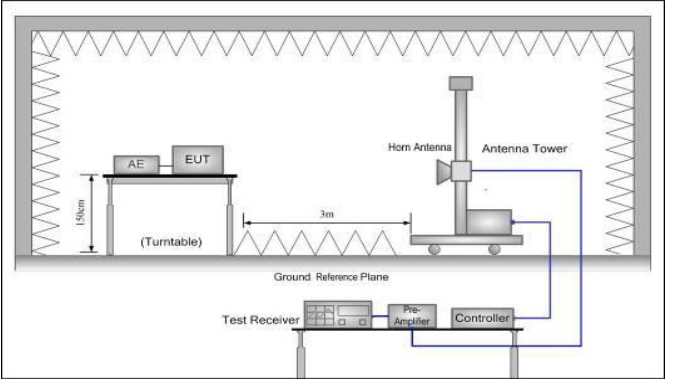
Lowest channel



Date: 20.AUG.2019 15:16:20

Highest channel

6.5 Field strength of spurious radiation measurement

Test Requirement:	Part 22.917(b)
Test Method:	ANSI/TIA-603-D 2010
Limit:	LTE Band 5: The power of any emission outside a licensee's frequency block shall be attenuated below the transmitter power (P) in watts by at least $43 + 10 \log_{10}(P)$ dB (-13 dBm).
Test setup:	Below 1GHz  Above 1GHz 
Test Procedure:	1. The EUT was placed on an non-conductive turntable using a non-conductive support. The radiated emission at the fundamental frequency was measured at 3 m with a test antenna and EMI spectrum analyzer. 2. During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. This maximization process was repeated with the EUT positioned in each of its three orthogonal orientations. 3. The frequency range up to tenth harmonic was investigated for each of three fundamental frequency (low, middle and high channels). Once spurious emission was identified, the power of the emission was determined using the substitution method. 4. The spurious emissions attenuation was calculated as the difference between radiated power at the fundamental frequency and the spurious emissions frequency. $ERP / EIRP = S.G. \text{ output (dBm)} + \text{Antenna Gain(dB/dBi)} - \text{Cable Loss (dB)}$
Test Instruments:	Refer to section 5.9 for details
Test mode:	Refer to section 5.3 for details.
Test results:	Passed

Measurement Data:

LTE Band 5 part:

LTE Band 5, WB: 1.4MHz				
RB size 1 & RB offset 0				
Frequency (MHz)	Spurious Emission		Limit (dBm)	Result
	Polarization	Level (dBm)		
Lowest Channel				
1649.40	Vertical	-53.79	-13.00	Pass
2474.10	V	-54.20		
3298.80	V	-49.95		
1649.40	Horizontal	-53.54		
2474.10	H	-52.24		
3298.80	H	-49.83		
Middle Channel				
1673.00	Vertical	-53.16	-13.00	Pass
2509.50	V	-54.72		
3346.00	V	-49.25		
1673.00	Horizontal	-53.29		
2509.50	H	-52.86		
3346.00	H	-49.48		
Highest Channel				
1696.60	Vertical	-53.54	-13.00	Pass
2544.90	V	-54.16		
3393.20	V	-49.83		
1696.60	Horizontal	-53.96		
2544.90	H	-52.62		
3393.20	H	-49.06		
Note: 1. The emission levels of below 1 GHz are 20 dB lower than the limit so not show in this report. 2. For above 1 GHz, all test modes were performed, and just the worst case shown in the report.				

LTE Band 5, WB: 3MHz				
RB size 1 & RB offset 0				
Frequency (MHz)	Spurious Emission		Limit (dBm)	Result
	Polarization	Level (dBm)		
Lowest Channel				
1651.00	Vertical	-53.41	-13.00	Pass
2476.50	V	-54.48		
3302.00	V	-49.43		
1651.00	Horizontal	-53.69		
2476.50	H	-52.27		
3302.00	H	-49.61		
Middle Channel				
1673.00	Vertical	-53.55	-13.00	Pass
2509.50	V	-54.69		
3346.00	V	-49.62		
1673.00	Horizontal	-53.06		
2509.50	H	-52.16		
3346.00	H	-49.52		
Highest Channel				
1695.00	Vertical	-53.84	-13.00	Pass
2542.50	V	-54.61		
3390.00	V	-49.93		
1695.00	Horizontal	-53.45		
2542.50	H	-52.34		
3390.00	H	-49.53		
Note:				
1. The emission levels of below 1 GHz are 20 dB lower than the limit so not show in this report.				
2. For above 1 GHz, all test modes were performed, and just the worst case shown in the report.				

LTE Band 5, WB: 5MHz				
RB size 1 & RB offset 0				
Frequency (MHz)	Spurious Emission		Limit (dBm)	Result
	Polarization	Level (dBm)		
Lowest Channel				
1653.00	Vertical	-53.37	-13.00	Pass
2479.50	V	-54.29		
3306.00	V	-49.06		
1653.00	Horizontal	-53.53		
2479.50	H	-52.08		
3306.00	H	-49.41		
Middle Channel				
1673.00	Vertical	-53.37	-13.00	Pass
2509.50	V	-54.95		
3346.00	V	-49.66		
1673.00	Horizontal	-53.25		
2509.50	H	-52.58		
3346.00	H	-49.96		
Highest Channel				
1693.00	Vertical	-53.15	-13.00	Pass
2539.50	V	-54.42		
3386.00	V	-49.95		
1693.00	Horizontal	-53.37		
2539.50	H	-52.95		
3386.00	H	-49.12		
Note:				
1. The emission levels of below 1 GHz are 20 dB lower than the limit so not show in this report.				
2. For above 1 GHz, all test modes were performed, and just the worst case shown in the report.				

LTE Band 5, WB: 10MHz				
RB size 1 & RB offset 0				
Frequency (MHz)	Spurious Emission		Limit (dBm)	Result
	Polarization	Level (dBm)		
Lowest Channel				
1658.00	Vertical	-53.34	-13.00	Pass
2487.00	V	-54.21		
3316.00	V	-49.92		
1658.00	Horizontal	-53.14		
2487.00	H	-52.21		
3316.00	H	-49.04		
Middle Channel				
1673.00	Vertical	-53.34	-13.00	Pass
2509.50	V	-54.98		
3346.00	V	-49.59		
1673.00	Horizontal	-53.21		
2509.50	H	-52.36		
3346.00	H	-49.42		
Highest Channel				
1688.00	Vertical	-53.53	-13.00	Pass
2532.00	V	-54.63		
3376.00	V	-49.45		
1688.00	Horizontal	-53.27		
2532.00	H	-52.65		
3376.00	H	-49.67		
Note:				
1. The emission levels of below 1 GHz are 20 dB lower than the limit so not show in this report.				
2. For above 1 GHz, all test modes were performed, and just the worst case shown in the report.				

6.6 Frequency stability V.S. Temperature measurement

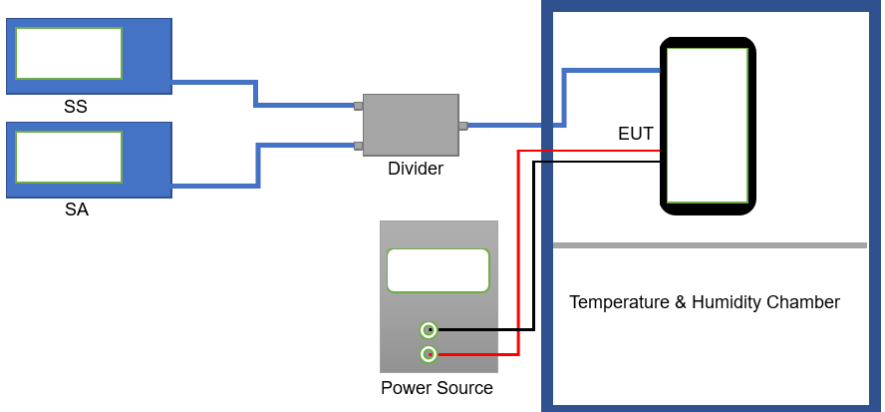
Test Requirement:	Part 22.355, Part 2.1055(a)(1)(b)
Test Method:	ANSI/TIA-603-D 2010
Limit:	$\pm 2.5\text{ppm}$
Test setup:	
Test procedure:	1. The equipment under test was connected to an external DC power supply and input rated voltage. 2. RF output was connected to a frequency counter or spectrum analyzer via feed through attenuators. 3. The EUT was placed inside the temperature chamber. 4. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and measure EUT 25°C operating frequency as reference frequency. 5. Turn EUT off and set the chamber temperature to -30°C. After the temperature stabilized for approximately 30 minutes recorded the frequency. 6. Repeat step measure with 10°C increased per stage until the highest temperature of +50°C reached
Test Instruments:	Refer to section 5.9 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed

Measurement Data (worst case):

LTE Band 5 part:

Reference Frequency: LTE Band 5 (10MHz) Middle channel=20525 channel=836.50MHz					
Power supplied (Vdc)	Temperature (°C)	Frequency error		Limit (ppm)	Result
		Hz	ppm		
QPSK					
3.85	-30	189	0.225914	±2.5	Pass
	-20	147	0.175711		
	-10	156	0.186469		
	0	13	0.015539		
	10	163	0.194836		
	20	130	0.155391		
	30	105	0.125508		
	40	126	0.150610		
	50	114	0.136266		
16QAM					
3.85	-30	177	0.211571	±2.5	Pass
	-20	146	0.174516		
	-10	126	0.150610		
	0	123	0.147024		
	10	120	0.143438		
	20	132	0.157781		
	30	145	0.173321		
	40	158	0.188860		
	50	169	0.202008		
Note: Only the worst case shown in the report.					

6.7 Frequency stability V.S. Voltage measurement

Test Requirement:	Part 22.355, Part 2.1055(d)(2)
Test Method:	ANSI/TIA-603-D 2010
Limit:	±2.5ppm
Test setup:	 The diagram illustrates the test setup. A Signal Source (SS) and a Spectrum Analyzer (SA) are connected to a Divider. The output of the Divider is connected to the EUT (Equipment Under Test) inside a Temperature & Humidity Chamber. A Power Source is also connected to the EUT.
Test procedure:	1. Set chamber temperature to 25°C. Use a variable DC power source to power the EUT and set the voltage to rated voltage. 2. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency. 3. Reduce the input voltage to specify extreme voltage variation (+/- 15%) and endpoint, record the maximum frequency change.
Test Instruments:	Refer to section 5.9 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed

Measurement Data (worst case):

LTE Band 5 part:

Reference Frequency: LTE Band 5(10MHz) Middle channel=20525 channel=836.50MHz					
Temperature (°C)	Power supplied (Vdc)	Frequency error		Limit (ppm)	Result
		Hz	ppm		
QPSK					
25	4.43	96	0.114750	±2.5	Pass
	3.85	14	0.016734		
	3.27	76	0.090844		
16QAM					
25	4.43	88	0.105188	±2.5	Pass
	3.85	45	0.053789		
	3.27	65	0.077695		
Note: Only the worst case shown in the report.					